

FEATURES

- Complete 16-channel, 12-bit digital-to-analog converter
- 4 mm × 4 mm WLCSP package
- Integrated DAC output buffers with ±20 mA output current capability
- Integrated reference buffers
- Channel monitoring multiplexer
- 1.8 V logic compatibility
- Temperature range: -40°C to +105°C

APPLICATIONS

- Mach Zehnder modulator bias control
- Optical modules
- Bias control
- Analog output modules

GENERAL DESCRIPTION

The AD5767 is a 16-channel, 12-bit, voltage output denseDAC[®] digital-to-analog converter (DAC).

The DAC generates output voltage ranges from an external 2.5 V reference. Depending on the voltage range selected, the midpoint of the output span can be adjusted, allowing a minimum output voltage as low as -20 V or a maximum output voltage of up to +14 V. Each of the 16 channels can be monitored with an integrated output multiplexer.

The AD5767 has integrated output buffers that can sink or source up to 20 mA. In conjunction with these buffers, a low frequency signal can be superimposed onto each DAC output via dedicated dither pins. These dedicated dither pins simplify the system design by reducing the number of external components required for a similar external implementation, like operational amplifiers or resistors. The reduction of external components makes the AD5767 suitable for indium phosphide Mach Zehnder modulator (InP MZM) biasing applications.

The device incorporates a power-on reset (POR) circuit that ensures that the DAC outputs are clamped to GND on power up and remain at this level until the output range of the DAC is configured. The outputs of all DACs are updated through register configuration, with the added functionality of user-selectable DAC channels to be simultaneously updated.

The AD5767 utilizes a versatile 4-wire serial interface that operates at clock rates of up to 50 MHz for write mode and is compatible with serial peripheral interface (SPI), QSPI[™], MICROWIRE[™], and DSP interface standards. The AD5767 also contains a V_{LOGIC} pin intended for 1.8 V/3 V/5 V logic.

The AD5767 is available in a 4 mm × 4 mm WLCSP package and a 40-lead LFCSP package. The AD5767 operates at a temperature range of -40°C to +105°C.

FUNCTIONAL BLOCK DIAGRAM

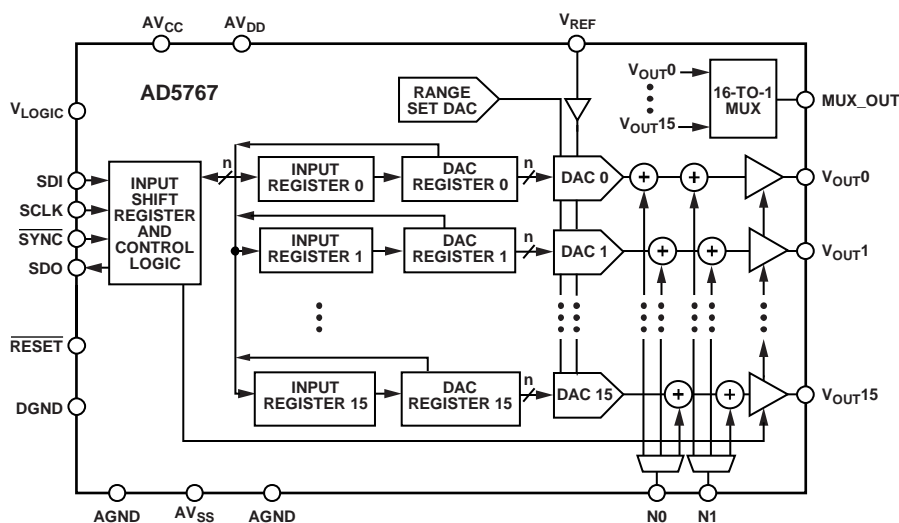


Figure 1.

Rev. A

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REVISION HISTORY

4/2017—Rev. 0 to Rev. A

| | |
|--|-----------|
| Added 40-Lead LFCSP Package..... | Universal |
| Changes to Features..... | 1 |
| Changes to General Description | 1 |
| Changes to Functional Block Diagram, Figure 1 | 1 |
| Added Figure 6 and Added Table 7, Renumbered Sequentially | 12 |
| Changes to Figure 23 and Figure 24..... | 16 |
| Added Figure 26..... | 17 |
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| Changes to Dither DC Shift Section | 20 |
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| Changes to Layout Guidelines Section and Added Figure 47 .. | 33 |
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| Changes to Ordering Guide..... | 35 |

1/2017—Revision 0: Initial Version

SPECIFICATIONS

$V_{CC} = 2.97\text{ V to }5.5\text{ V}$, $V_{LOGIC} = 1.7\text{ V to }5.5\text{ V}$, $V_{DD} = 2.97\text{ V to }16\text{ V}$, $V_{SS} = -22\text{ V to }-7\text{ V}$, $AGND = DGND = 0\text{ V}$, $V_{REF} = 2.5\text{ V}$, output range = $\pm 5\text{ V}$, V_{OUTX} unloaded, all specifications $-40^{\circ}\text{C to }+105^{\circ}\text{C}$, typical specifications at 25°C , unless otherwise noted.

Table 1.

| Parameter | Min | Typ | Max | Unit | Test Conditions/Comments |
|--|------------|------------|-------|--------------------------------|--|
| STATIC PERFORMANCE | | | | | |
| Resolution | 12 | | | Bits | |
| Relative Accuracy (INL) | -1 | | +1 | LSB | -10V to 0V range and $\pm 5\text{ V}$ range |
| | -1.5 | | +1.5 | LSB | -20V to 0V, -16V to 0V, -10V to +6V, $\pm 10\text{ V}$, -12V to +14V, and -16V to +10V ranges |
| Differential Nonlinearity | -1 | | +1 | LSB | Guaranteed monotonic by design |
| Bipolar Zero Error | -85 | ± 12 | +85 | mV | $\pm 5\text{ V}$ range |
| | -110 | ± 13 | +110 | mV | -10V to +6V range |
| | -120 | ± 15 | +120 | mV | $\pm 10\text{ V}$ range |
| | -145 | ± 16 | +145 | mV | -12V to +14V range |
| | -145 | ± 16 | +145 | mV | -16V to +10V range |
| Bipolar Zero Error Temperature Coefficient (TC) ¹ | | ± 2 | | ppm FSR/ $^{\circ}\text{C}$ | |
| Zero-Scale Error | | | | | All 0s loaded to DAC register |
| | -80 | ± 25 | +80 | mV | -10V to 0V range |
| | -80 | ± 25 | +80 | mV | $\pm 5\text{ V}$ range |
| | -110 | ± 35 | +110 | mV | -16V to 0V range |
| | -110 | ± 35 | +110 | mV | -10V to +6V range |
| | -130 | ± 35 | +130 | mV | -20V to 0V range |
| | -130 | ± 35 | +130 | mV | $\pm 10\text{ V}$ range |
| | -140 | ± 45 | +140 | mV | -12V to +14V range |
| -140 | ± 45 | +140 | mV | -16V to +10V range | |
| Zero-Scale Error Temperature Coefficient (TC) ¹ | | ± 2 | | ppm FSR/ $^{\circ}\text{C}$ | |
| Full-Scale Error | | | | | All 1s loaded to DAC register. |
| | -0.9 | ± 0.23 | +0.9 | % FSR | -10V to 0V range |
| | -0.9 | ± 0.23 | +0.9 | % FSR | $\pm 5\text{ V}$ range |
| | -0.8 | ± 0.2 | +0.8 | % FSR | -16V to 0V range |
| | -0.8 | ± 0.2 | +0.8 | % FSR | -10V to +6V range |
| | -0.7 | ± 0.18 | +0.7 | % FSR | -20V to 0V range |
| | -0.7 | ± 0.18 | +0.7 | % FSR | $\pm 10\text{ V}$ range |
| | -0.6 | ± 0.15 | +0.6 | % FSR | -12V to +14V range |
| -0.6 | ± 0.15 | +0.6 | % FSR | -16V to +10V range | |
| Full-Scale Error Drift | | ± 3 | | ppm FSR/ $^{\circ}\text{C}$ | |
| Gain Error | -0.4 | ± 0.07 | +0.4 | % FSR | |
| Gain Error Temperature Coefficient (TC) ¹ | | ± 2 | | ppm FSR/ $^{\circ}\text{C}$ | |
| Offset Error | -80 | ± 25 | +80 | mV | -10V to 0V range |
| | -80 | ± 25 | +80 | mV | $\pm 5\text{ V}$ range |
| | -110 | ± 35 | +110 | mV | -16V to 0V range |
| | -110 | ± 35 | +110 | mV | -10V to +6V range |
| | -130 | ± 35 | +130 | mV | -20V to 0V range |
| | -130 | ± 35 | +130 | mV | $\pm 10\text{ V}$ range |
| | -140 | ± 45 | +140 | mV | -12V to +14V range |
| -140 | ± 45 | +140 | mV | -16V to +10V range | |
| Offset Error Drift ¹ | | ± 2 | | $\mu\text{V}/^{\circ}\text{C}$ | |

| Parameter | Min | Typ | Max | Unit | Test Conditions/Comments |
|---|--------------------------|--------|--------------------------|--------|---|
| Total Unadjusted Error | -0.9 | ±0.18 | +0.9 | %FSR | -10 V to 0 V range |
| | -0.9 | ±0.18 | +0.9 | %FSR | ±5 V range |
| | -0.8 | ±0.15 | +0.8 | %FSR | -16 V to 0 V range |
| | -0.8 | ±0.15 | +0.8 | %FSR | -10 V to +6 V range |
| | -0.7 | ±0.13 | +0.7 | %FSR | -20 V to 0 V range |
| | -0.7 | ±0.13 | +0.7 | %FSR | ±10 V range |
| | -0.6 | ±0.12 | +0.6 | %FSR | -12 V to +14 V range |
| | -0.6 | ±0.12 | +0.6 | %FSR | -16 V to +10 V range |
| DC Crosstalk ¹ | | 30 | | μV | Due to output voltage change |
| | | 35 | | μV/mA | Due to load current change (1 LSB) |
| OUTPUT CHARACTERISTICS | | | | | |
| Output Voltage Ranges ² | -20 | | 0 | V | |
| | -16 | | 0 | V | |
| | -10 | | 0 | V | |
| | -10 | | +6 | V | |
| | -12 | | +14 | V | |
| | -16 | | +10 | V | |
| | -5 | | +5 | V | |
| | -10 | | +10 | V | |
| Output Current ¹ | -20 | | +20 | mA | Refer to the Thermal Considerations section |
| Capacitive Load Stability ¹ | | | 1 | nF | |
| DC Output Impedance ¹ | | 0.2 | | Ω | |
| Short-Circuit Current ¹ | | ±60 | | mA | Single channel only |
| Output Amplifier Bandwidth ¹ | | 108 | | kHz | |
| REFERENCE INPUT¹ | | | | | |
| Reference Input Voltage | | 2.5 | | V | ±1% for specified performance |
| Reference Range | 2.375 | | 2.625 | V | Functional performance only |
| DC Input Impedance | 2.5 | | | MΩ | |
| Input Current | | | 1 | μA | |
| DITHER INPUTS | | | | | |
| Dither Frequency ¹ | | 10 | | kHz | For dither input to DAC output attenuation ¹ , see Figure 36 to Figure 39 for typical performance Lower -3 dB point |
| | | 100 | | kHz | Upper -3 dB point |
| Amplitude ¹ | | | 0.25 | V p-p | Peak-to-peak ac voltage |
| | 0 | | AV _{CC} | V | Peak-to-peak ac and dc voltage |
| DC Shift | -1 | ±0.063 | +1 | LSB | See the Terminology section |
| Dither Transient ¹ | | | | | Dither enabled/disabled, N0 and N1 floating |
| Dither Selected Channel | | 5 | | nV-sec | AV _{CC} = 2.97 V and AV _{CC} = 5.5 V |
| Dither Nonselected Channels | | 2 | | nV-sec | AV _{CC} = 2.97 V and AV _{CC} = 5.5 V |
| Dither Crosstalk ¹ | | -70 | | dB | 10 kHz dither frequency |
| | | -55 | | dB | 100 kHz dither frequency |
| LOGIC INPUTS¹ | | | | | |
| Input High Voltage, V _{IH} | 0.7 × V _{LOGIC} | | | V | |
| Input Low Voltage, V _{IL} | | | 0.3 × V _{LOGIC} | V | |
| Input Current | -2 | | +2 | μA | Per pin |
| | -6 | | +6 | μA | RESET pin pulled high |
| | -57 | | +57 | μA | RESET pin pulled low |
| Input Capacitance | | 2 | | pF | Per pin |
| LOGIC OUTPUT¹ | | | | | |
| Output Low Voltage | | | 0.4 | V | Sinking 200 μA |

| Parameter | Min | Typ | Max | Unit | Test Conditions/Comments |
|---|--------------------------|-------|-----|------------------------|--|
| Output High Voltage | $V_{\text{LOGIC}} - 0.4$ | | | V | Sourcing 200 μA |
| High Impedance Leakage Current | -1 | | +1 | μA | |
| High Impedance Output Capacitance | | 5 | | pF | |
| VOLTAGE MONITOR PIN (MUX_OUT) | | | | | |
| Impedance ¹ | | 1.3 | | k Ω | |
| Three-State Leakage Current | -1 | 0.006 | +1 | μA | |
| Continuous Current ¹ | -1 | | +1 | mA | Die temperature below 105°C |
| Glitch Impulse ¹ | | 0.2 | | nV-sec | V_{OUTX} glitch due to mux enable |
| Voltage Settling Time ¹ | | 12 | | μs | ¼ to ¾ scale settling to ± 0.5 LSB, ± 5 V range and -10 V to 0 V range |
| POWER SUPPLIES | | | | | |
| AV_{DD} | 2.97 | | 16 | V | $AV_{\text{DD}} - AV_{\text{SS}}$ must be less than or equal to 30 V |
| AV_{SS} | -22 | | -7 | V | $AV_{\text{DD}} - AV_{\text{SS}}$ must be less than or equal to 30 V |
| AV_{CC} | 2.97 | | 5.5 | V | |
| V_{LOGIC} | 1.7 | | 5.5 | V | |
| Headroom/Footroom ¹ | | 2 | | V | Applies to AV_{DD} and AV_{SS} |
| Normal Mode | | | | | |
| I_{DD} | | 6 | 8 | mA | All output ranges, -40°C to +105°C |
| I_{SS} | -11 | -9 | | mA | All output ranges, -40°C to +105°C |
| I_{CC} | | 8.3 | 10 | mA | All output ranges, -40°C to +105°C |
| I_{LOGIC} | | 0.02 | 1 | μA | All output ranges, -40°C to +105°C, $V_{\text{IH}} = V_{\text{LOGIC}}$, $V_{\text{IL}} = \text{DGND}$ |
| Power-Down Mode | | | | | All channels powered down |
| I_{DD} | | 0.11 | 0.3 | mA | |
| I_{SS} | -0.5 | -0.16 | | mA | |
| I_{CC} | | 0.14 | 0.3 | mA | $AV_{\text{CC}} = 3.3\text{V}$ |
| | | 0.55 | 0.8 | mA | See Figure 30 |
| I_{LOGIC} | | 0.02 | 1 | μA | |
| DC Power Supply Rejection Ratio (PSRR) ¹ | | 50 | | $\mu\text{V}/\text{V}$ | AV_{DD} power supply |
| | | 50 | | $\mu\text{V}/\text{V}$ | AV_{SS} power supply |
| | | 3 | | mV/V | AV_{CC} power supply |
| AC Power Supply Rejection Ratio (PSRR) ¹ | | -80 | | dB | AV_{DD} power supply, at 50 Hz |
| | | -80 | | dB | AV_{SS} power supply, at 50 Hz |
| | | -50 | | dB | AV_{CC} power supply, at 50 Hz |

¹ Guaranteed by design and characterization, but not production tested.

² Output amplifier headroom requirement is 2 V minimum.

AC PERFORMANCE CHARACTERISTICS

$AV_{CC} = 2.97\text{ V to }5.5\text{ V}$, $V_{LOGIC} = 1.7\text{ V to }5.5\text{ V}$, $AV_{DD} = 2.97\text{ V to }15\text{ V}$, $AV_{SS} = -22\text{ V to }-7\text{ V}$, $AGND = DGND = 0\text{ V}$, $V_{REF} = 2.5\text{ V}$, output range = $-10\text{ V to }0\text{ V}$, V_{OUTX} unloaded, all specifications $-40^{\circ}\text{C to }+105^{\circ}\text{C}$, typical specifications at 25°C , analog dither signals not applied, unless otherwise noted.

Table 2.

| Parameter | Min | Typ | Max | Unit | Test Conditions/Comments |
|--|-----|-----|-----|------------------------------|---|
| DYNAMIC PERFORMANCE¹ | | | | | |
| Output Voltage Settling Time ² | | 10 | | μs | $\frac{1}{4}$ to $\frac{3}{4}$ scale settling to ± 0.5 LSB, $\pm 5\text{ V}$ range and $-10\text{ V to }0\text{ V}$ range |
| | | 4 | | μs | 32 LSB step to ± 0.5 LSB |
| Slew Rate ² | | 1 | | $\text{V}/\mu\text{s}$ | |
| Digital-to-Analog Glitch Energy ² | | 10 | | $\text{nV}\cdot\text{sec}$ | 1 LSB change around major carry for 10 V span |
| Glitch Impulse Peak Amplitude ² | | 8 | | mV | |
| Digital Feedthrough ² | | 1 | | $\text{nV}\cdot\text{sec}$ | |
| Digital Crosstalk ² | | 0.2 | | $\text{nV}\cdot\text{sec}$ | |
| Analog Crosstalk ² | | 15 | | $\text{nV}\cdot\text{sec}$ | |
| DAC-to-DAC Crosstalk ² | | 15 | | $\text{nV}\cdot\text{sec}$ | |
| Total Harmonic Distortion ² | | -80 | | dB | $V_{REF} = 2.5\text{ V} \pm 0.1\text{ V p-p}$, frequency = 10 kHz, $AV_{CC} = 2.97\text{ V}$ and 3.3 V |
| | | -75 | | dB | $V_{REF} = 2.5\text{ V} \pm 0.1\text{ V p-p}$, frequency = 10 kHz, $AV_{CC} = 5.5\text{ V}$ |
| Output Noise Spectral Density ^{1,2} | | 375 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-10\text{ V to }0\text{ V}$ and $\pm 5\text{ V}$ ranges, frequency = 1 kHz |
| | | 605 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-16\text{ V to }0\text{ V}$ and $-10\text{ V to }+6\text{ V}$ ranges, frequency = 1 kHz |
| | | 750 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-20\text{ V to }0\text{ V}$ and $\pm 10\text{ V}$ ranges, frequency = 1 kHz |
| | | 835 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-12\text{ V to }14\text{ V}$ and $-16\text{ V to }+10\text{ V}$ ranges, frequency = 1 kHz |
| | | 280 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-10\text{ V to }0\text{ V}$ and $\pm 5\text{ V}$ ranges, frequency = 10 kHz |
| | | 440 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-16\text{ V to }0\text{ V}$ and $-10\text{ V to }+6\text{ V}$ ranges, frequency = 10 kHz |
| | | 470 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-20\text{ V to }0\text{ V}$ and $\pm 10\text{ V}$ ranges, frequency = 10 kHz |
| Output Noise ^{2,3} | | 610 | | $\text{nV}/\sqrt{\text{Hz}}$ | $-12\text{ V to }14\text{ V}$ and $-16\text{ V to }+10\text{ V}$ ranges, frequency = 10 kHz |
| | | | | | Dither disabled |
| | | 20 | | $\mu\text{V rms}$ | $\pm 5\text{ V}$ range |
| | | 23 | | $\mu\text{V rms}$ | $-10\text{ V to }0\text{ V}$ range |
| | | 33 | | $\mu\text{V rms}$ | $-10\text{ V to }+6\text{ V}$ range |
| | | 38 | | $\mu\text{V rms}$ | $-16\text{ V to }0\text{ V}$ range |
| | | 36 | | $\mu\text{V rms}$ | $\pm 10\text{ V}$ range |
| | | 45 | | $\mu\text{V rms}$ | $-20\text{ V to }0\text{ V}$ range |
| | | 45 | | $\mu\text{V rms}$ | $-16\text{ V to }10\text{ V}$ range |
| | | 45 | | $\mu\text{V rms}$ | $-12\text{ V to }14\text{ V}$ range |

¹ DAC code = midscale. $AV_{DD} = V_{OUT_MAX} + 2\text{ V}$. $AV_{SS} = V_{OUT_MIN} - 2\text{ V}$.

² Guaranteed by design and characterization, but not production tested.

³ 0.1 Hz to 10 Hz. $AV_{DD} = V_{OUT_MAX} + 2\text{ V}$. $AV_{SS} = V_{OUT_MIN} - 2\text{ V}$.

TIMING CHARACTERISTICS

All input signals are specified with $t_R = t_F = 1 \text{ ns/V}$ (10% to 90% of AV_{DD}) and timed from a voltage level of $(V_{IL} + V_{IH})/2$. See Figure 2, Figure 3, and Figure 4.

$AV_{CC} = 2.97 \text{ V to } 5.5 \text{ V}$, $V_{LOGIC} = 1.7 \text{ V to } 5.5 \text{ V}$, $V_{REF} = 2.5 \text{ V}$, all specifications $-40^\circ\text{C to } +105^\circ\text{C}$, unless otherwise noted.

Table 3.

| Parameter | Limit at T_{MIN}, T_{MAX} | Unit | Description |
|-----------|-----------------------------|-------------------|---|
| t_1^1 | 20 | ns min | SCLK cycle time |
| t_2 | 10 | ns min | SCLK high time |
| t_3 | 10 | ns min | SCLK low time |
| t_4 | 15 | ns min | $\overline{\text{SYNC}}$ falling edge to SCLK falling edge setup time |
| t_5 | 15 | ns min | SCLK falling edge to $\overline{\text{SYNC}}$ rising edge time |
| t_6 | 20 | ns min | Minimum $\overline{\text{SYNC}}$ high time (write mode) |
| t_7 | 5 | ns min | Data setup time |
| t_8 | 5 | ns min | Data hold time |
| t_9 | 4 | $\mu\text{s typ}$ | DAC output settling time, 32 code step to $\pm 0.5 \text{ LSB}$ at 12-bit resolution (see Table 2) |
| t_{10} | 100 | ns typ | $\overline{\text{RESET}}^2$ pulse width low |
| t_{11} | 100 | ns typ | $\overline{\text{RESET}}^2$ pulse activation time |
| t_{12} | 10 | ns min | $\overline{\text{SYNC}}$ rising edge to SCLK falling edge |
| t_{13} | 40 | ns max | SCLK rising edge to SDO valid ($C_{L_SDO}^3 = 15 \text{ pF}$) |
| t_{14} | 50 | ns typ | Minimum $\overline{\text{SYNC}}$ high time (readback/daisy-chain mode) |
| t_{15} | 20 | $\mu\text{s typ}$ | $\overline{\text{SYNC}}$ rising edge to $\overline{\text{SYNC}}$ rising edge (DAC register updates); not shown in Figure 2, Figure 3, or Figure 4 |

¹ Maximum SCLK frequency is 50 MHz for write mode and 10 MHz for readback mode.
² Minimum time between a reset and the subsequent successful write is typically 25 ns.
³ C_{L_SDO} is the capacitive load on the SDO output.

Timing Diagrams

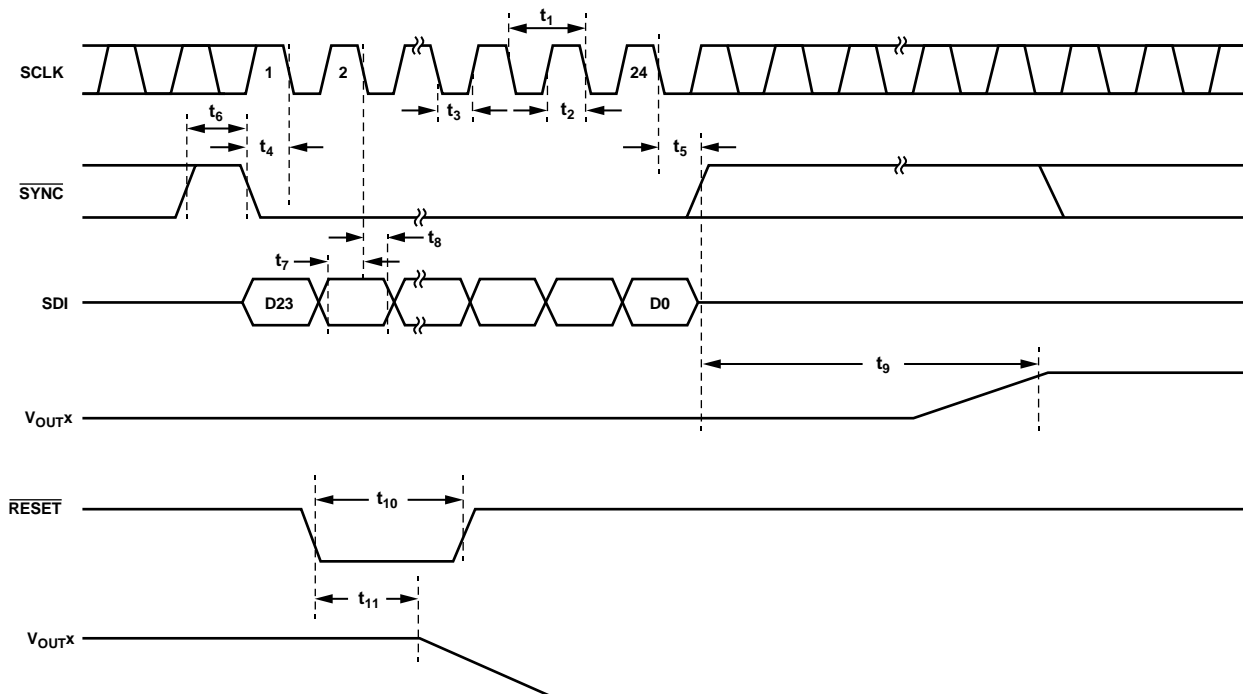


Figure 2. Serial Interface Timing Diagram

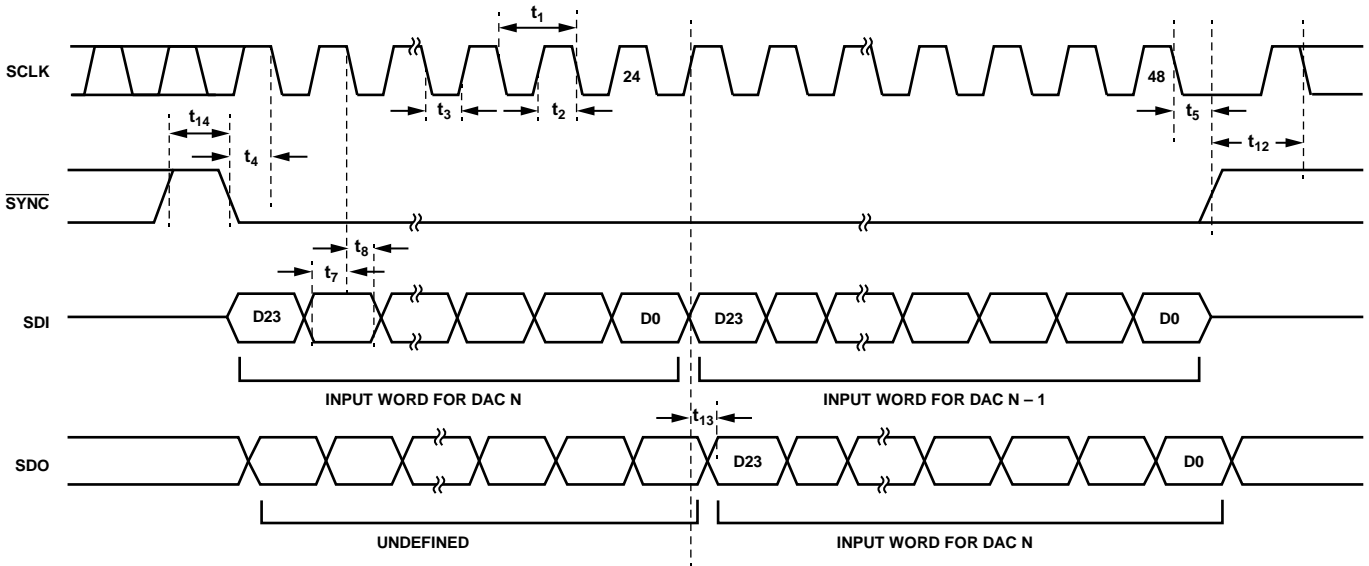


Figure 3. Daisy-Chain Timing Diagram

15145-003

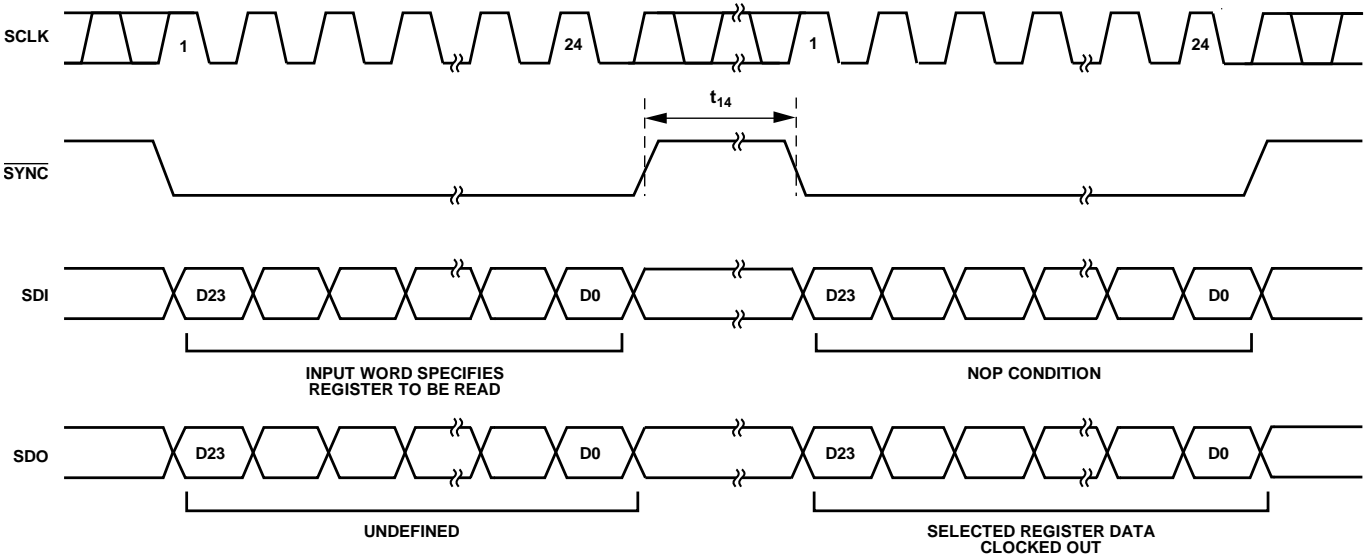


Figure 4. Readback Timing Diagram

15145-004

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted. Transient currents of up to 100 mA do not cause silicon controlled rectifier (SCR) latch-up.

Table 4.

| Parameter | Rating |
|--|--|
| AV_{DD} to AGND | -0.3 V to +34 V |
| AV_{SS} to AGND | +0.3 V to -34 V |
| AV_{DD} to AV_{SS} | -0.3 V to +34 V |
| AV_{CC} to AGND | -0.3 V to +7 V |
| AV_{CC} to AGND | -0.3 V to $AV_{DD} + 0.3$ V |
| V_{LOGIC} to DGND | -0.3 V to +7 V |
| Digital Inputs ¹ to DGND | -0.3 V to $V_{LOGIC} + 0.3$ V |
| Digital Output (SDO) to DGND | -0.3 V to $V_{LOGIC} + 0.3$ V |
| N0, N1 to AGND | -0.3 V to $AV_{CC} + 0.3$ V |
| V_{REF} to AGND | -0.3 V to $AV_{CC} + 0.3$ V |
| V_{OUTX} to AGND | $AV_{SS} - 0.3$ V to $AV_{DD} + 0.3$ V |
| AGND to DGND | -0.3 V to +0.3 V |
| Operating Temperature Range, T_A Industrial | -40°C to +105°C |
| Storage Temperature Range | -65°C to +150°C |
| Junction Temperature, T_{JMAX} | 150°C |
| Power Dissipation | $(T_{JMAX} - T_A)/\theta_{JA}$ |
| Lead Temperature Soldering Reflow | 260°C, as per JEDEC J-STD-020 |

¹ The digital inputs include $\overline{\text{RESET}}$, $\overline{\text{SCLK}}$, $\overline{\text{SYNC}}$, and SDI.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

THERMAL RESISTANCE

Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Careful attention to PCB thermal design is required.

θ_{JA} is the natural convection junction to ambient thermal resistance measured in a one cubic foot sealed enclosure.

Table 5. Thermal Resistance

| Package Type | θ_{JA} | Unit |
|----------------------|---------------|------|
| CB-49-4 ¹ | 53 | °C/W |
| CP-40-7 ¹ | 31.71 | °C/W |

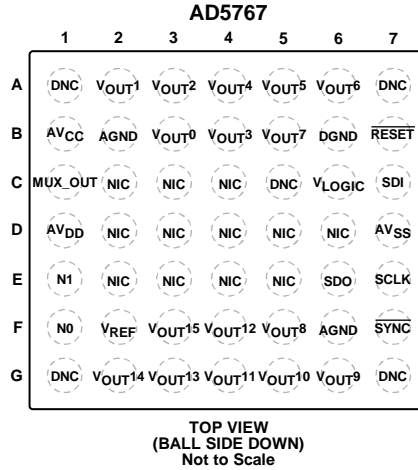
¹ Thermal impedance simulated values are based on JEDEC 2S2P thermal test board with 16 thermal vias. See JEDEC JESD51.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



NOTES

1. DNC = DO NOT CONNECT. DO NOT CONNECT TO THESE PINS.
2. NIC = NO INTERNAL CONNECTION. THESE PINS SHOULD BE ROUTED TO THERMAL VIAS ON THE PCB TO AID WITH HEAT DISSIPATION. THESE SHOULD BE CONNECTED TO GROUND.

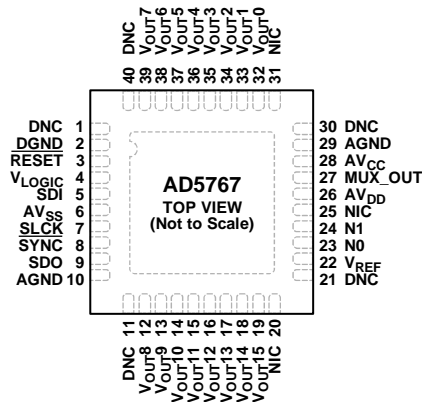
151445-005

Figure 5. WLCSP Package Pin Configuration

Table 6. 49-Ball WLCSP Pin Function Descriptions

| Pin No. | Mnemonic | Description |
|--------------------------|-------------------|--|
| Dither | | |
| F1 | N0 | Dither Signal Input Pin 0. A signal connected to this pin can be added to the DAC outputs via register commands. If unused, connect this pin to ground. Refer to the Dither section for more information. |
| E1 | N1 | Dither Signal Input Pin 1. A signal connected to this pin can be added to the DAC outputs via register commands. If unused, connect this pin to ground. Refer to the Dither section for more information. |
| Logic Inputs and Outputs | | |
| E7 | SCLK | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz for write mode and 10 MHz for readback and daisy-chain mode. |
| F7 | SYNC | Active Low Control Input. <u>SYNC</u> is the frame synchronization signal for the input data. When <u>SYNC</u> goes low, it powers on the SCLK and SDI buffers and enables the input shift register. Data is transferred in on the falling edges of the next 24 clocks. If <u>SYNC</u> is taken high before the 24 th falling edge, the rising edge of <u>SYNC</u> acts as an interrupt, and the write sequence is ignored by the device. |
| C7 | SDI | Serial Data Input. This device has a 24-bit shift register. Data is clocked into the register on the falling edge of the serial clock input. |
| E6 | SDO | Serial Data Output. This pin clocks data from the serial register in daisy-chain or readback mode. Data is clocked out on the rising edge of SCLK and is valid on the falling edge of SCLK. |
| B7 | RESET | Active Low Reset Input. Asserting this pin logic low returns the AD5767 to its default power-on state. After this pin returns to logic high, the device comes out of the reset mode and is ready to accept a new SPI command. This pin can be left floating, because there is a weak internal pull-up resistor. |
| Analog Outputs | | |
| B3 | V _{OUT0} | Analog Output Voltage from DAC 0. |
| A2 | V _{OUT1} | Analog Output Voltage from DAC 1. |
| A3 | V _{OUT2} | Analog Output Voltage from DAC 2. |
| B4 | V _{OUT3} | Analog Output Voltage from DAC 3. |
| A4 | V _{OUT4} | Analog Output Voltage from DAC 4. |
| A5 | V _{OUT5} | Analog Output Voltage from DAC 5. |
| A6 | V _{OUT6} | Analog Output Voltage from DAC 6. |

| Pin No. | Mnemonic | Description |
|------------------------------------|--------------------|---|
| B5 | V _{OUT7} | Analog Output Voltage from DAC 7. |
| F5 | V _{OUT8} | Analog Output Voltage from DAC 8. |
| G6 | V _{OUT9} | Analog Output Voltage from DAC 9. |
| G5 | V _{OUT10} | Analog Output Voltage from DAC 10. |
| G4 | V _{OUT11} | Analog Output Voltage from DAC 11. |
| F4 | V _{OUT12} | Analog Output Voltage from DAC 12. |
| G3 | V _{OUT13} | Analog Output Voltage from DAC 13. |
| G2 | V _{OUT14} | Analog Output Voltage from DAC 14. |
| F3 | V _{OUT15} | Analog Output Voltage from DAC 15. |
| Power Supplies and Reference Input | | |
| F2 | V _{REF} | Reference Input Voltage. For specified performance, V _{REFIN} = 2.5 V. |
| C6 | V _{LOGIC} | Digital Power Supply. |
| B1 | AV _{CC} | Power Supply Input. The AD5767 operates from 2.97 V to 5.5 V. Decouple AV _{CC} with a 10 μF capacitor in parallel with a 0.1 μF capacitor to analog ground. |
| D1 | AV _{DD} | Output Amplifier Positive Analog Supply. |
| D7 | AV _{SS} | Output Amplifier Negative Analog Supply. |
| B2, F6 | AGND | Analog Ground. |
| B6 | DGND | Digital Ground Pin. |
| Channel Monitoring | | |
| C1 | MUX_OUT | Monitor Output. This pin acts as the output of a 16-to-1 channel multiplexer that can be programmed to multiplex one of 16 channels, Channel 0 to Channel 15, to the MUX_OUT pin. |
| Do Not Connect | | |
| A1, A7, C5, G1, G7 | DNC | Do Not Connect. Do not connect to these pins. |
| No Internal Connection | | |
| C2 to C4, D2 to D6, E2 to E5 | NIC | No Internal Connection. Route these pins to thermal vias on the PCB to aid with heat dissipation. Connect these pins to ground. |



- NOTES**
1. DNC = DO NOT CONNECT. DO NOT CONNECT TO THESE PINS.
 2. NIC = NO INTERNAL CONNECTION. THESE PINS SHOULD BE ROUTED TO THERMAL VIAS ON THE PCB TO AID WITH HEAT DISSIPATION. THESE SHOULD BE CONNECTED TO GROUND.
 3. EXPOSED PAD (LFCSP PACKAGE ONLY). CONNECT THIS EXPOSED PAD TO THE POTENTIAL OF THE AVSS PIN, OR, ALTERNATIVELY, LEAVE IT ELECTRICALLY UNCONNECTED. IT IS RECOMMENDED THAT THE PAD BE THERMALLY CONNECTED TO A COPPER PLANE FOR ENHANCED THERMAL PERFORMANCE.

15145-006

Figure 6. LFCSP Package Pin Configuration

Table 7. 40-Lead LFCSP Pin Function Descriptions

| Pin No. | Mnemonic | Description |
|-------------------------------|---------------------------|--|
| Dither 23 | N0 | Dither Signal Input Pin 0. A signal connected to this pin can be added to the DAC outputs via register commands. If unused, connect this pin to ground. Refer to the Dither section for more information. |
| 24 | N1 | Dither Signal Input Pin 1. A signal connected to this pin can be added to the DAC outputs via register commands. If unused, connect this pin to ground. Refer to the Dither section for more information. |
| Logic Inputs and Outputs 7 | SCLK | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 50 MHz for write mode and 10 MHz for readback and daisy-chain mode. |
| 8 | $\overline{\text{SYNC}}$ | Active Low Control Input. $\overline{\text{SYNC}}$ is the frame synchronization signal for the input data. When $\overline{\text{SYNC}}$ goes low, it powers on the SCLK and SDI buffers and enables the input shift register. Data is transferred in on the falling edges of the next 24 clocks. If $\overline{\text{SYNC}}$ is taken high before the 24 th falling edge, the rising edge of $\overline{\text{SYNC}}$ acts as an interrupt, and the write sequence is ignored by the device. |
| 5 | SDI | Serial Data Input. This device has a 24-bit shift register. Data is clocked into the register on the falling edge of the serial clock input. |
| 9 | SDO | Serial Data Output. This pin clocks data from the serial register in daisy-chain or readback mode. Data is clocked out on the rising edge of SCLK and is valid on the falling edge of SCLK. |
| 3 | $\overline{\text{RESET}}$ | Active Low Reset Input. Asserting this pin logic low returns the AD5767 to its default power-on state. After this pin returns to logic high, the device comes out of the reset mode and is ready to accept a new SPI command. This pin can be left floating, because there is a weak internal pull-up resistor. |
| Analog Outputs 32 | V _{OUT0} | Analog Output Voltage from DAC 0. |
| 33 | V _{OUT1} | Analog Output Voltage from DAC 1. |
| 34 | V _{OUT2} | Analog Output Voltage from DAC 2. |
| 35 | V _{OUT3} | Analog Output Voltage from DAC 3. |
| 36 | V _{OUT4} | Analog Output Voltage from DAC 4. |
| 37 | V _{OUT5} | Analog Output Voltage from DAC 5. |

| Pin No. | Mnemonic | Description |
|------------------------------------|--------------------|---|
| 38 | V _{OUT6} | Analog Output Voltage from DAC 6. |
| 39 | V _{OUT7} | Analog Output Voltage from DAC 7. |
| 12 | V _{OUT8} | Analog Output Voltage from DAC 8. |
| 13 | V _{OUT9} | Analog Output Voltage from DAC 9. |
| 14 | V _{OUT10} | Analog Output Voltage from DAC 10. |
| 15 | V _{OUT11} | Analog Output Voltage from DAC 11. |
| 16 | V _{OUT12} | Analog Output Voltage from DAC 12. |
| 17 | V _{OUT13} | Analog Output Voltage from DAC 13. |
| 18 | V _{OUT14} | Analog Output Voltage from DAC 14. |
| 19 | V _{OUT15} | Analog Output Voltage from DAC 15. |
| Power Supplies and Reference Input | | |
| 22 | V _{REF} | Reference Input Voltage. For specified performance, V _{REFIN} = 2.5 V. |
| 4 | V _{LOGIC} | Digital Power Supply. |
| 28 | AV _{CC} | Power Supply Input. The AD5767 operates from 2.97 V to 5.5 V. Decouple AV _{CC} with a 10 μF capacitor in parallel with a 0.1 μF capacitor to analog ground. |
| 26 | AV _{DD} | Output Amplifier Positive Analog Supply. |
| 6 | AV _{SS} | Output Amplifier Negative Analog Supply. |
| 10, 29 | AGND | Analog Ground. |
| 2 | DGND | Digital Ground Pin. |
| Channel Monitoring | | |
| 27 | MUX_OUT | Monitor Output. This pin acts as the output of a 16-to-1 channel multiplexer that can be programmed to multiplex one of 16 channels, Channel 0 to Channel 15, to the MUX_OUT pin. |
| Do Not Connect | | |
| 1, 11, 21, 30, 40 | DNC | Do Not Connect. Do not connect to these pins. |
| No Internal Connection | | |
| 20, 25, 31 | NIC | No Internal Connection. Route these pins to thermal vias on the PCB to aid with heat dissipation. Connect these pins to ground. |
| Not Applicable | | |
| | EPAD | Exposed Pad. Connect this exposed pad to the potential of the AV _{SS} pin, or, alternatively, leave it electrically unconnected. It is recommended that the exposed pad be thermally connected to a copper plane for enhanced thermal performance. |

TYPICAL PERFORMANCE CHARACTERISTICS

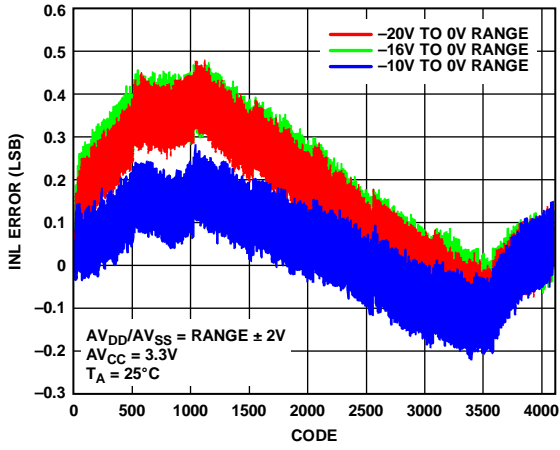


Figure 7. INL Error vs. DAC Code (Unipolar Output)

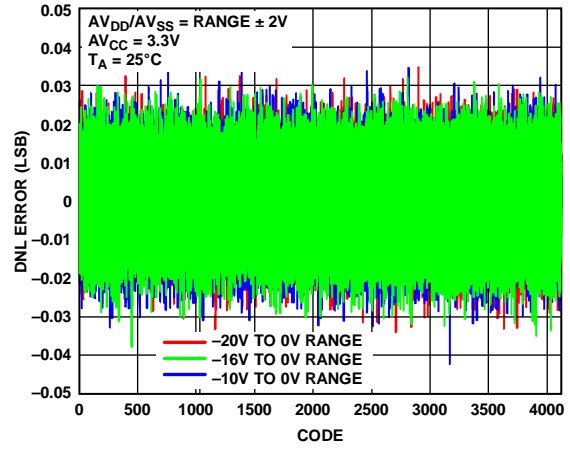


Figure 10. DNL Error vs. DAC Code (Unipolar Outputs)

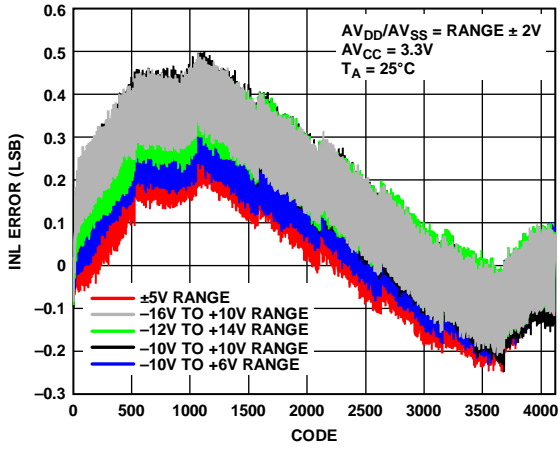


Figure 8. INL Error vs. DAC Code (Bipolar Outputs)

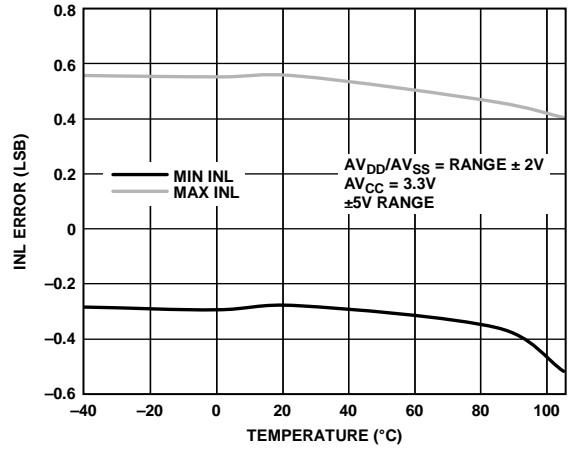


Figure 11. INL Error vs. Temperature

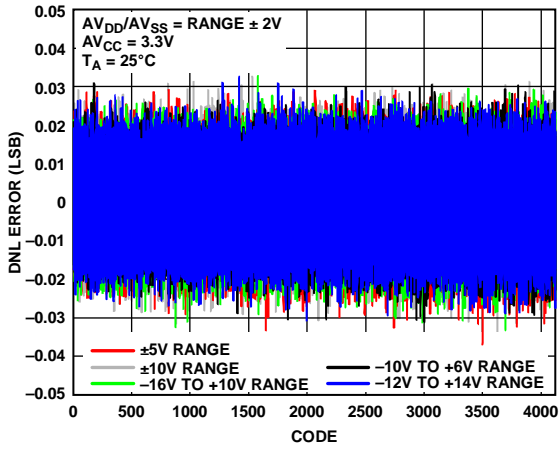


Figure 9. DNL Error vs. DAC Code (Bipolar Outputs)

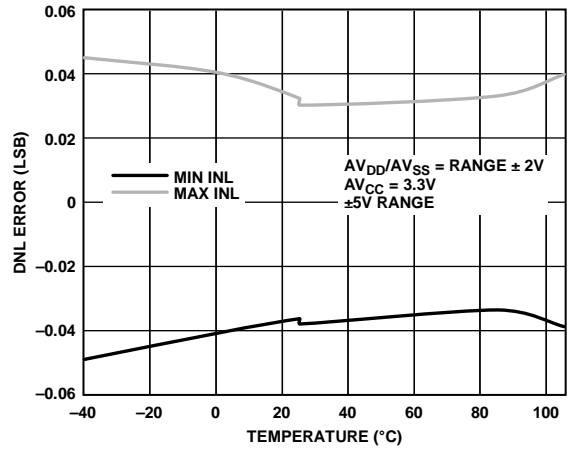


Figure 12. DNL Error vs. Temperature

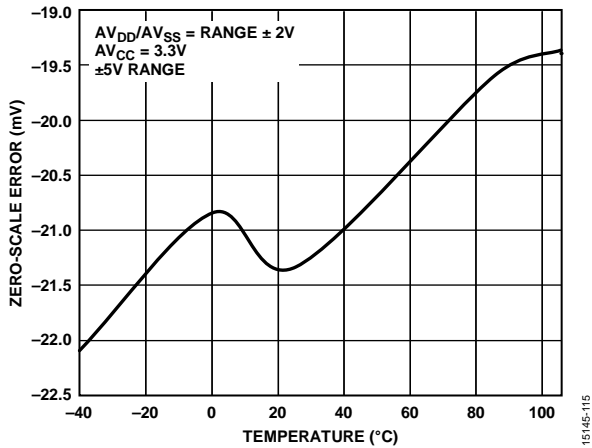


Figure 13. Zero-Scale Error vs. Temperature

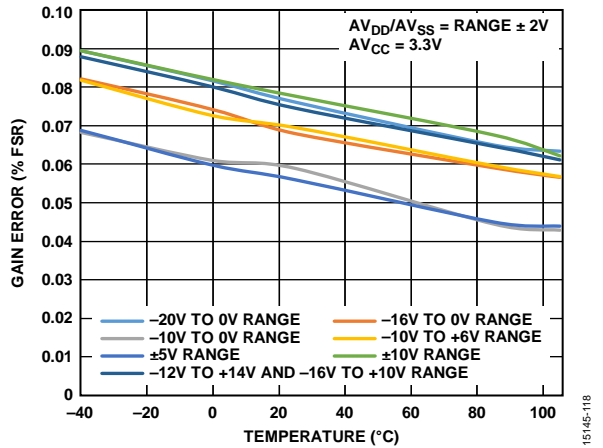


Figure 16. Gain Error vs. Temperature

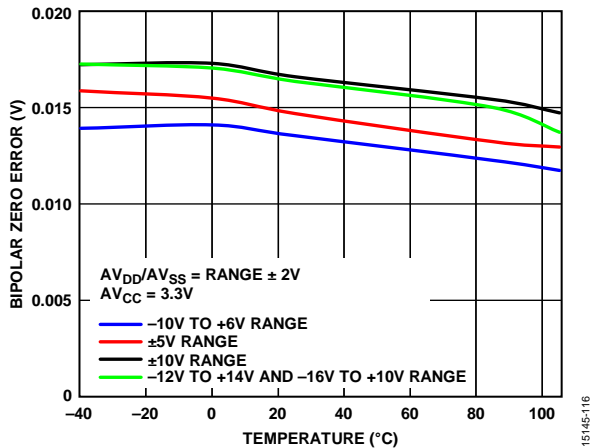


Figure 14. Bipolar Zero Error vs. Temperature

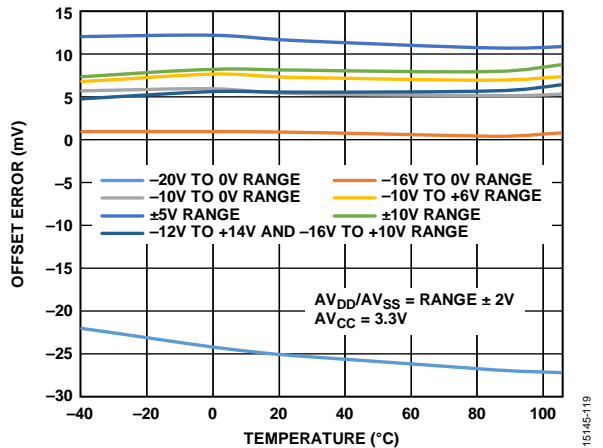


Figure 17. Offset Error vs. Temperature

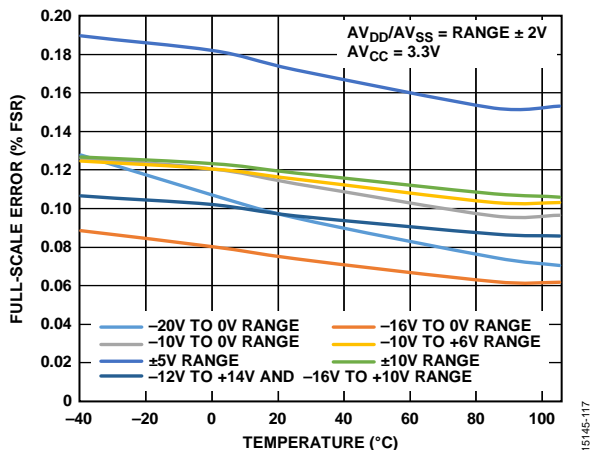


Figure 15. Full-Scale Error vs. Temperature

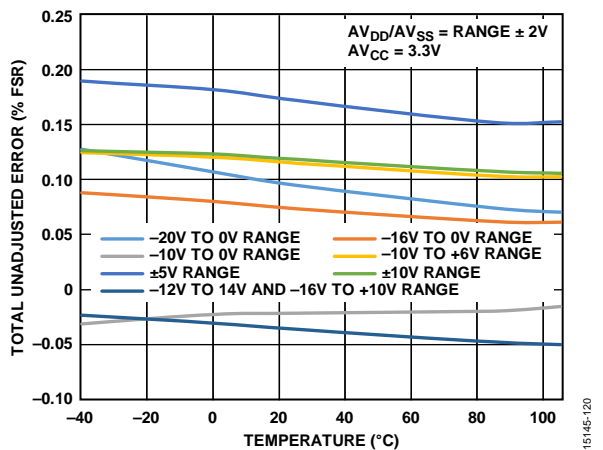


Figure 18. Total Unadjusted Error vs. Temperature

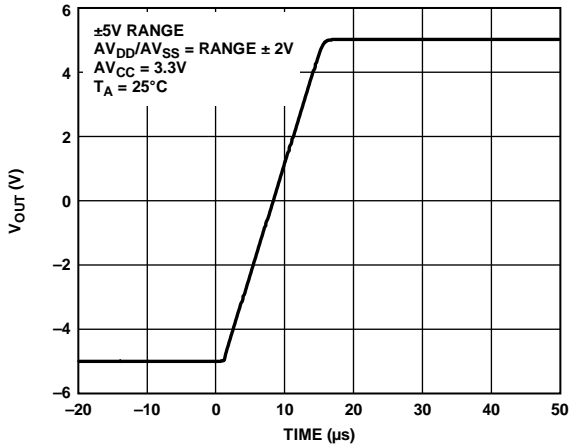


Figure 19. Full-Scale Settling Time (Rising Voltage Step)

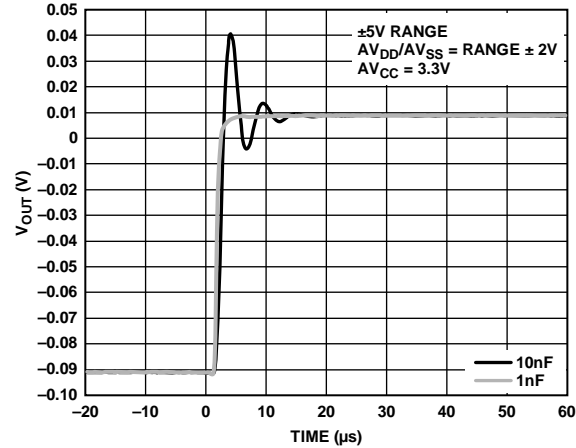


Figure 22. Output Voltage vs. Settling Time at Various Capacitive Loads

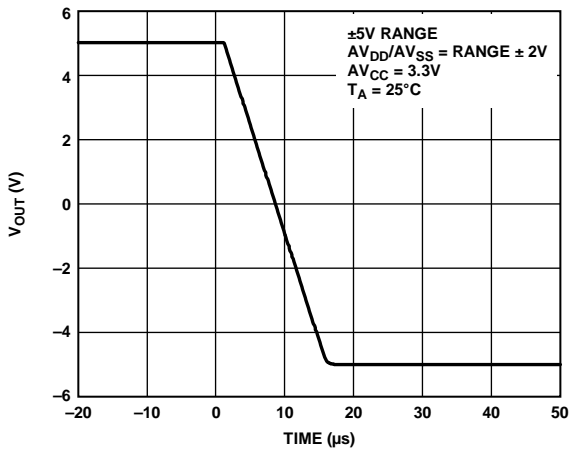


Figure 20. Full-Scale Settling Time (Falling Voltage Step)

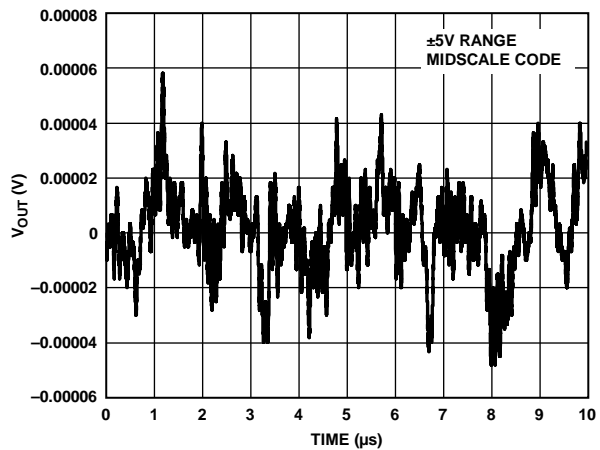


Figure 23. Peak to Peak Noise (0.1 Hz to 10 Hz Bandwidth) with Dither Disabled

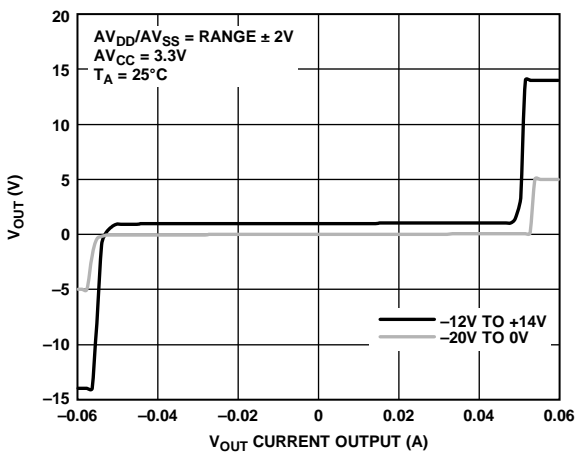


Figure 21. Source and Sink Capability of Output Amplifier

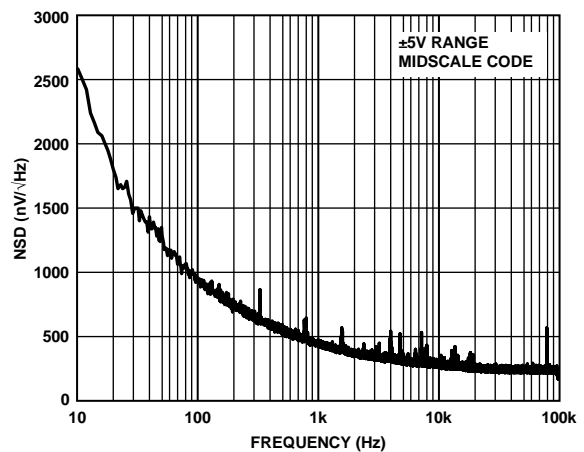


Figure 24. Noise Spectral Density (NSD) vs. Frequency

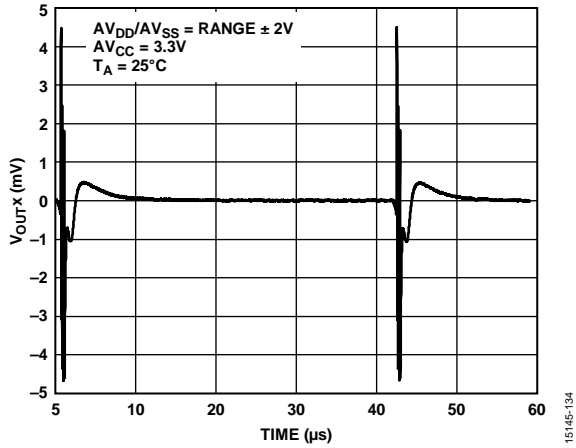


Figure 25. Digital Feedthrough for WLCSP Package

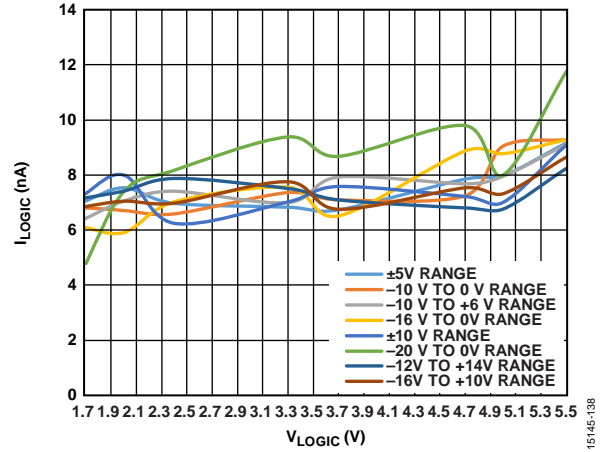


Figure 28. Logic Current (I_{LOGIC}) vs. Logic Input Voltage (V_{LOGIC})

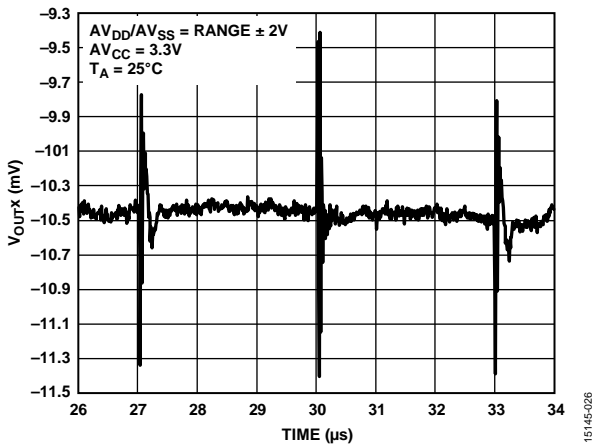


Figure 26. Digital Feedthrough for LFCSP Package

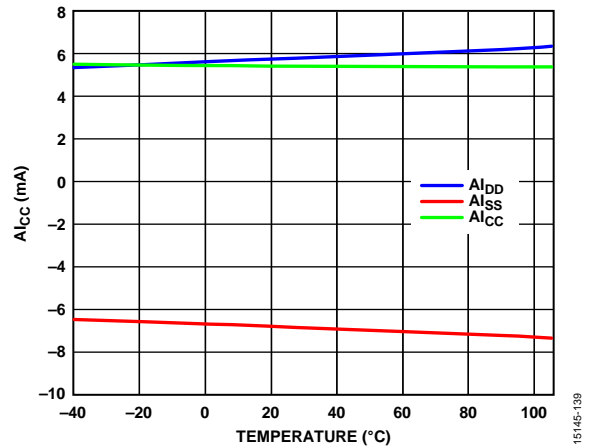


Figure 29. Supply Current in Normal Mode (A_{LCC}) vs. Temperature

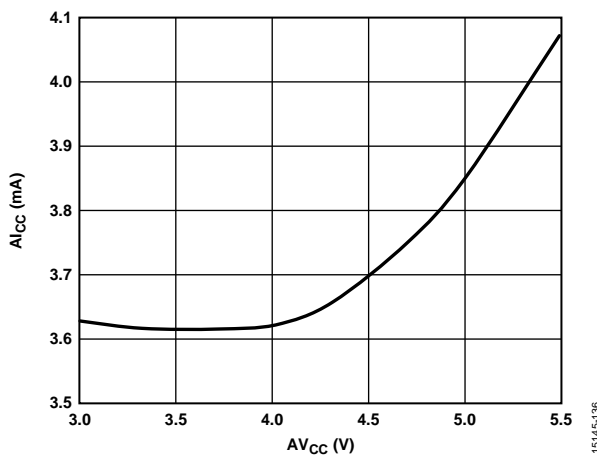


Figure 27. Supply Current in Normal Mode (A_{LCC}) vs. Supply Voltage (A_{VCC})

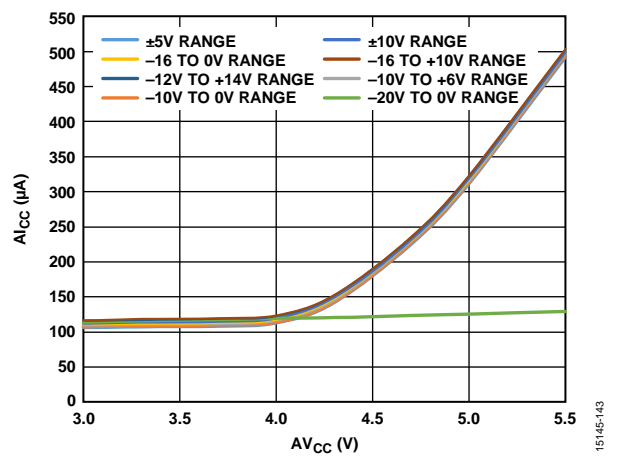


Figure 30. Supply Current in Power-Down Mode (A_{LCC}) vs. Supply Voltage (A_{VCC})

DITHER

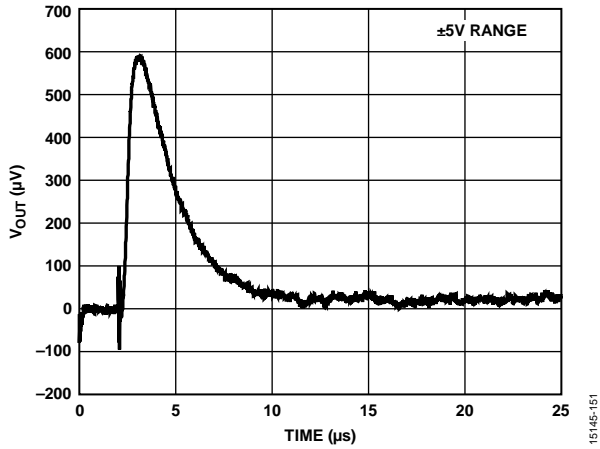


Figure 31. Transient on Dither Selected Channel (Dither Enabled)

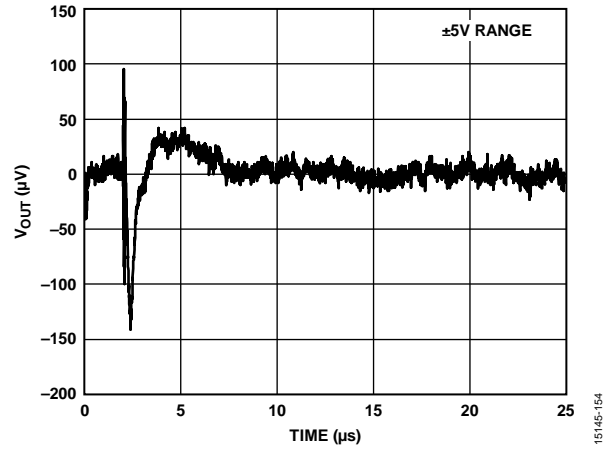


Figure 34. Transient on Nondither Selected Channel (Dither Disabled)

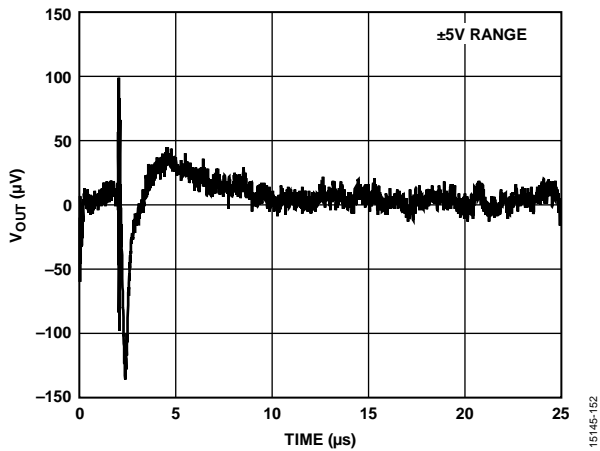


Figure 32. Transient on Nondither Selected Channel (Dither Enabled)

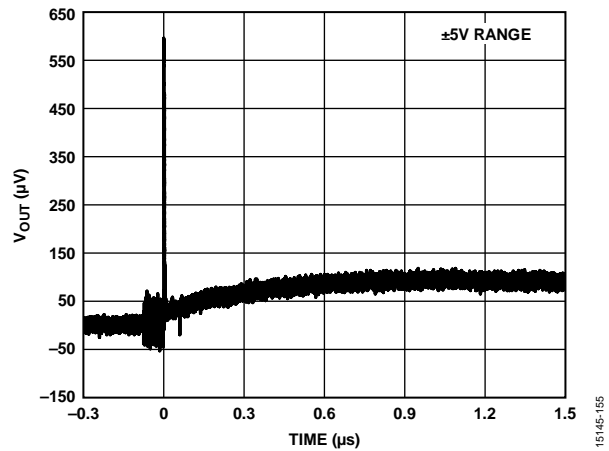


Figure 35. Dither DC Shift

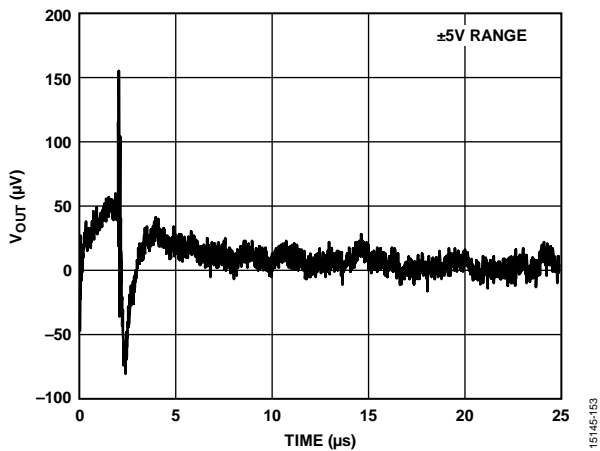


Figure 33. Transient on Dither Selected Channel (Dither Disabled)

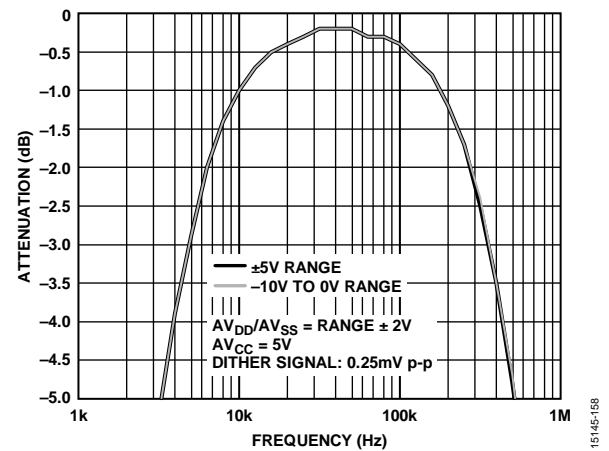


Figure 36. Dither Input to DAC Output Attenuation vs. Frequency (±5V Range and -10V to 0V Range)

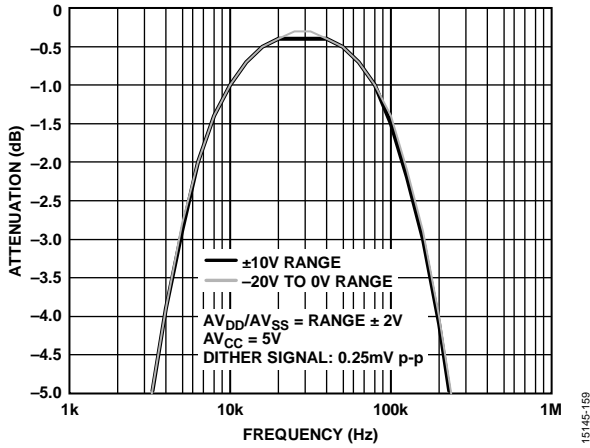


Figure 37. Dither Input to DAC Output Attenuation vs. Frequency ($\pm 10\text{ V}$ Range and -20 V to 0 V Range)

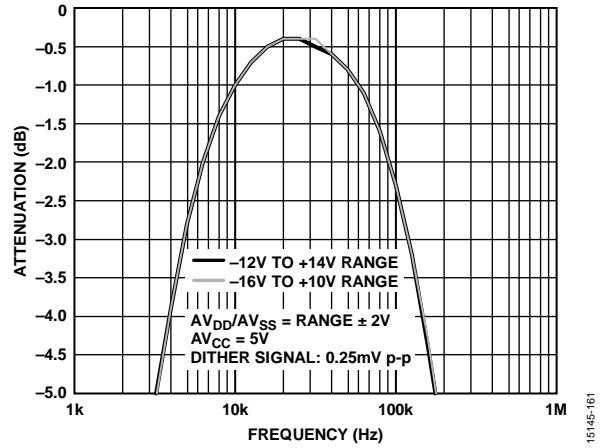


Figure 39. Dither Input to DAC Output Attenuation vs. Frequency (-12 V to $+14\text{ V}$ Range and -16 V to $+10\text{ V}$ Range)

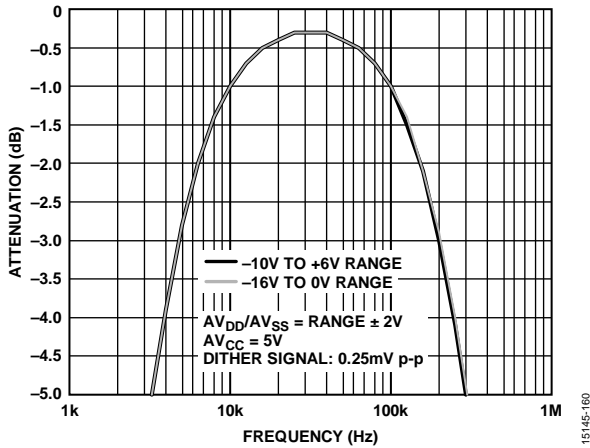


Figure 38. Dither Input to DAC Output Attenuation vs. Frequency (-10 V to $+6\text{ V}$ Range and -16 V to 0 V Range)

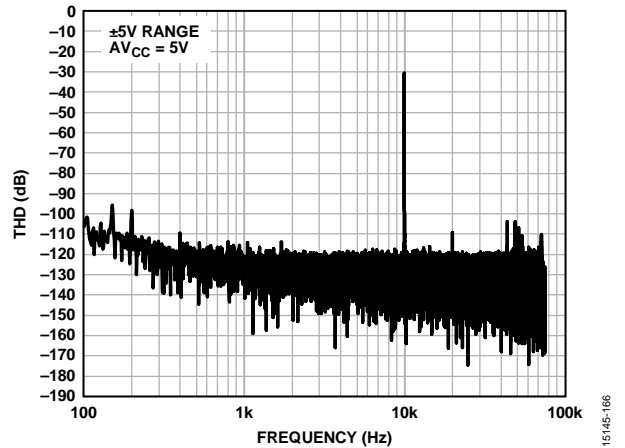


Figure 40. Total Harmonic Distortion (THD) vs. Frequency

TERMINOLOGY

Total Unadjusted Error (TUE)

Total unadjusted error is a measure of the output error taking all the various errors into account, namely INL error, offset error, gain error, and output drift over supplies, temperature, and time. TUE is expressed in % FSR.

Relative Accuracy or Integral Nonlinearity (INL)

Relative accuracy or integral nonlinearity is a measurement of the maximum deviation, in LSBs, from a straight line passing through the endpoints of the DAC transfer function. Typical INL error vs. DAC code plots are shown in Figure 7 and Figure 8.

Differential Nonlinearity (DNL)

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of ± 1 LSB maximum ensures monotonicity. This DAC is guaranteed monotonic by design. Typical DNL error vs. DAC code plots are shown in Figure 9 and Figure 10.

Zero-Scale Error

Zero-scale error is a measurement of the output error when zero code (0x0000) is loaded to the DAC register. Zero code error is expressed in mV.

Zero-Scale Error Temperature Coefficient

Zero code error drift is a measure of the change in zero code error with a change in temperature. It is expressed in $\mu\text{V}/^\circ\text{C}$.

Bipolar Zero Error

Bipolar zero error is the deviation of the analog output from the ideal half-scale output of 0 V when the DAC register is loaded with 0x2000.

Bipolar Zero Error Temperature Coefficient

Bipolar zero drift is a measure of the change in the bipolar zero error with a change in temperature. It is expressed in $\mu\text{V}/^\circ\text{C}$.

Gain Error

Gain error is a measure of the span error of the DAC. It is the deviation in slope of the DAC transfer characteristic from the ideal expressed as % FSR.

Gain Error Temperature Coefficient

Gain temperature coefficient is a measurement of the change in gain error with changes in temperature. It is expressed in ppm of FSR/ $^\circ\text{C}$.

Offset Error

Offset error is a measurement of the difference between V_{OUTX} (actual) and V_{OUTX} (ideal), expressed in mV, in the linear region of the transfer function. Offset error can be negative or positive.

Offset Error Drift

Offset error drift is a measurement of the change in offset error with a change in temperature. It is expressed in $\mu\text{V}/^\circ\text{C}$.

Dither DC Shift

Dither dc shift is a measurement of the dc voltage difference between V_{OUTX} (actual) and V_{OUTX} (ideal) due to the coupling of a dither tone to the analog output. It is expressed in LSB.

Dither Transient

Dither transient is the amplitude of the impulse injected into the analog outputs due to the enabling or disabling of the dither functionality on an output channel. The transients are measured the selected output channel and the other nonselected channels. It is specified in nV-sec.

DC Power Supply Rejection Ratio (PSRR)

PSRR indicates how the output of the DAC is affected by changes in the supply voltage. PSRR is the ratio of the change in V_{OUTX} to a change in AV_{DD} for a full-scale output of the DAC. It is measured in V/V.

Output Voltage Settling Time

Output voltage settling time is the amount of time it takes for the output of a DAC to settle to a specified level for a $\frac{1}{4}$ to $\frac{3}{4}$ full-scale input change and is measured from the rising edge of SYNC.

Digital-to-Analog Glitch Impulse

Digital-to-analog glitch impulse is the impulse injected into the analog output when the input code in the DAC register changes state. It is normally specified as the area of the glitch in nV-sec, and is measured when the digital input code is changed by 1 LSB at the major carry transition (0x7FF to 0x800 for the AD5767).

Digital Feedthrough

Digital feedthrough is a measure of the impulse injected into the analog output of the DAC from the digital inputs of the DAC, but is measured when the DAC output is not updated. It is specified in nV-sec, and measured with a full-scale code change on the data bus, that is, from all 0s to all 1s and vice versa.

DC Crosstalk

DC crosstalk is the dc change in the output level of one DAC in response to a change in the output of another DAC. It is measured with a full-scale output change on one DAC (or power-down and power-up) while monitoring another DAC maintained at midscale. It is expressed in μV .

DC crosstalk due to load current change is a measure of the impact that a change in load current on one DAC has to another DAC kept at midscale. It is expressed in $\mu\text{V}/\text{mA}$.

Digital Crosstalk

Digital crosstalk is the glitch impulse transferred to the output of one DAC at midscale in response to a full-scale code change (all 0s to all 1s and vice versa) in the input register of another DAC. It is measured in standalone mode and is expressed in nV-sec.

Analog Crosstalk

Analog crosstalk is the glitch impulse transferred to the output of one DAC due to a change in the output of another DAC. It is measured by loading one of the input registers with a full-scale code change (all 0s to all 1s and vice versa), then executing a software LDAC command (see Table 18), and monitoring the output of the DAC whose digital code was not changed. The area of the glitch is expressed in nV-sec.

DAC-to-DAC Crosstalk

DAC-to-DAC crosstalk is the glitch impulse transferred to the output of one DAC due to a digital code change and subsequent

analog output change of another DAC. It is measured by loading the attack channel with a full-scale code change (all 0s to all 1s and vice versa), using the write to and update commands while monitoring the output of the victim channel that is at midscale. The energy of the glitch is expressed in nV-sec.

Output Noise Spectral Density

Output noise spectral density is a measurement of the internally generated random noise. Random noise is characterized as a spectral density (nV/ $\sqrt{\text{Hz}}$). It is measured by loading the DAC to midscale and measuring noise at the output. It is measured in nV/ $\sqrt{\text{Hz}}$.

THEORY OF OPERATION

DIGITAL-TO-ANALOG CONVERTER

The AD5767 is a 16-channel, 12-bit, serial input, voltage output DAC capable of providing multiple output ranges with ± 20 mA output current capability. The available ranges are as follows:

- -20 V to 0 V
- -16 V to 0 V
- -10 V to 0 V
- -10 V to +6 V
- -12 V to +14 V
- -16 V to +10 V
- ± 5 V
- ± 10 V

The devices operate from four supply voltages: AV_{CC} , AV_{DD} , AV_{SS} , and V_{LOGIC} . AV_{CC} is the power supply input voltage for the DACs and other low voltage circuitry, whereas AV_{DD} and AV_{SS} are the positive and negative analog supplies for the output amplifiers. The output amplifiers require +2 V of headroom and -2 V of footroom. Table 8 shows the power supply requirements for the selected output range. V_{LOGIC} defines the logic levels for the digital input and output signals.

Table 8. Power Supply Requirements for the Selected Output Range

| Range (V) | AV_{SS} Maximum (V) | AV_{DD} Minimum (V) |
|------------|-----------------------|-----------------------|
| -20 to 0 | -22 | 2.97 |
| -16 to 0 | -18 | 2.97 |
| -10 to 0 | -12 | 2.97 |
| -10 to +6 | -12 | 8 |
| -12 to +14 | -14 | 16 |
| -16 to +10 | -18 | 12 |
| -5 to +5 | -7 | 7 |
| -10 to +10 | -12 | 12 |

DAC ARCHITECTURE

The architecture of one DAC channel consists of a resistor string DAC followed by an output buffer amplifier. The voltage at the V_{REF} pin provides the reference voltage for the all DAC channels. Figure 41 shows a block diagram of the DAC architecture.

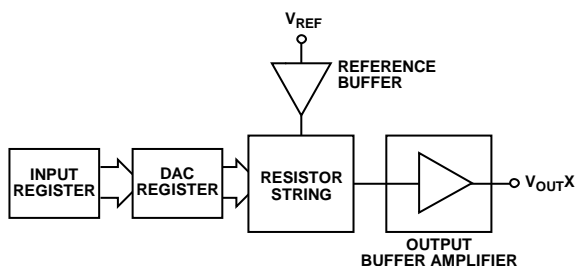


Figure 41. DAC Architecture

The input coding to the DAC is straight binary, the ideal output voltage is given by

$$V_{OUT} = \left(\text{Span} \times \frac{D}{N} \right) + V_{MIN}$$

where:

Span is the full extent of the DAC output voltage range from the minimum to the maximum limit.

D is the decimal equivalent of the binary code that is loaded to the DAC register.

N is 4096 for the 12-bit version.

V_{MIN} is the lowest voltage of the span.

RESISTOR STRING

The resistor string section is shown in Figure 42. It is a simplified resistor string structure, each of Value R . The digital code loaded to the DAC register determines at which node on the string the voltage is connected to be fed into the output amplifier. The voltage is tapped off by closing one of the switches connecting the string to the amplifier. Because a string of resistors is used, the DAC is guaranteed to be monotonic.

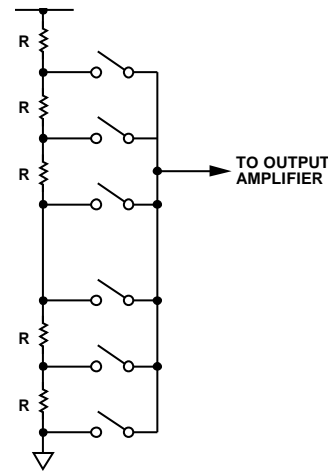


Figure 42. Resistor String

POWER-ON RESET (POR)

The AD5767 contains a POR circuit that controls the output voltage during power-up. The AD5767 outputs are clamped to GND at power-up and remain powered up at this level until a valid write sequence is made to the span register to configure the output range of the DAC. A software executable reset function resets the DAC to the power-up state. Command 0111 is reserved for this reset function (see Table 27). A minimum time is required between a reset and a successful write (see the timing characteristics in Table 3).

DITHER

External dither signals can be coupled onto any DAC output by writing the appropriate value to the dither registers. The dither signals are applied to the N0 and N1 input pins (see Figure 43). If dither is not required, connect these pins to AGND. The dither signals amplitude have a maximum peak-to-peak voltage (ac voltage) of 0.25 V p-p, and the absolute input voltage (ac and dc voltage) must not exceed the range of 0 V to V_{CC} . The dither signals can be attenuated and/or inverted internally on a per channel basis if required. Dither signals in the range of 10 kHz to 100 kHz can be applied to the dither input pins. Due to the nature of the internal dither circuitry, the dc value of the output can shift (see Table 1). For the recommended configuration of the dither functionality, see the Applications Information section.

POWER-DOWN MODE

The AD5767 contains two separate power-down modes of operation, a channel output power-down mode and a dither block power-down mode per channel. Command 0101 is reserved for the power-down function (see Table 9). These two power-down modes are software-programmable by setting four bits, Bit D19 to Bit D16, in the power control register. To address the power-down operation for DAC channel output,

D19 to D16 must be set to 0000, whereas a dither block power-down per channel function requires D19 to D16 to be set to 0001 (see Table 23). Table 25 shows how the state of the Bit D16 corresponds to the mode of operation of the device. Any or all DACs can be powered down to the selected mode by setting the corresponding 16 bits (D15 to D0) to 1.

To save on power consumption, it is recommended to place all unused DAC channels in power-down mode after all channels are enabled via the span register.

Ensure that all channels are powered up before writing to the span register.

MONITOR MUX

The AD5767 contains a channel monitor function that consists of an analog multiplexer addressed via the serial interface, allowing any channel output to be routed to the common MUX_OUT pin for external monitoring.

Because the MUX_OUT pin is not buffered, the amount of current drawn from this pin creates a voltage drop across the switches, which in turn leads to an error in the voltage being monitored. Therefore, the MUX_OUT pin must be connected to only high impedance inputs or externally buffered.

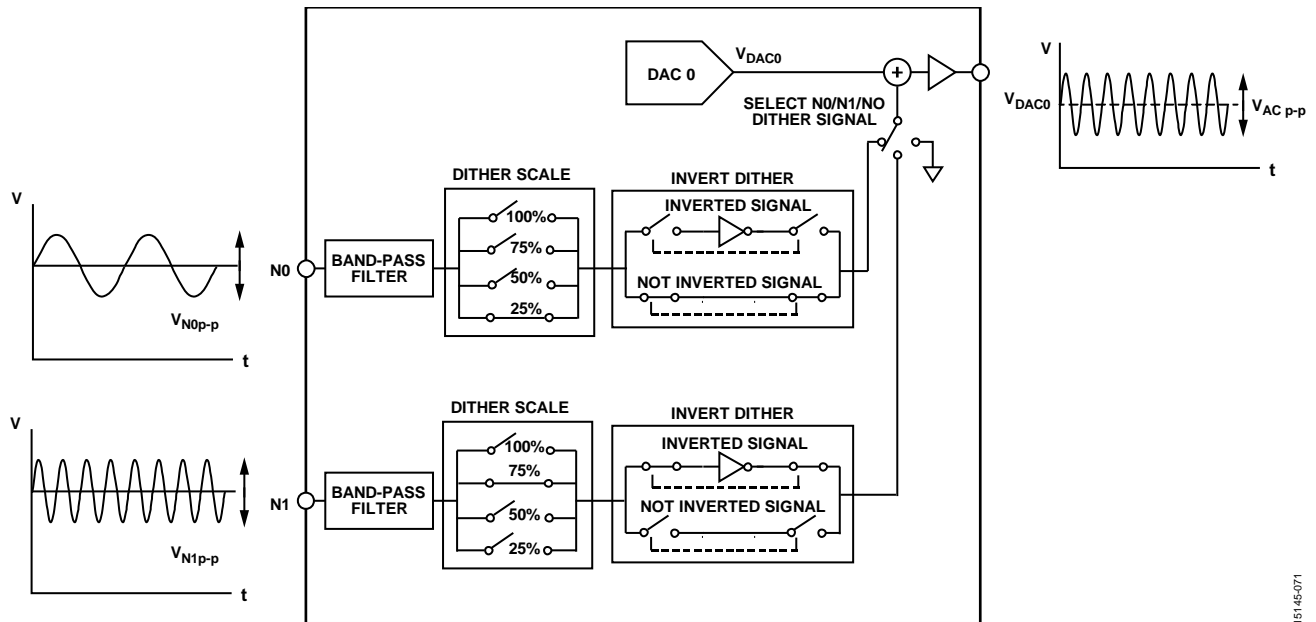


Figure 43. Dither Signal Generation

15145-071

SERIAL INTERFACE

The AD5767 4-wire (SYNC, SCLK, SDI, and SDO) interface is compatible with SPI, QSPI, and MICROWIRE interface standards as well as most digital signal processors (DSPs). The write sequence begins after bringing the SYNC line low, maintaining this line low until the complete data-word is loaded from the SDI pin. Data is loaded into the AD5767 at the SCLK falling edge transition (see Figure 2). When a rising edge is detected on SYNC, the serial data-word is decoded according to the instructions in Table 9. The command must be a multiple of 24; otherwise, the device ignores the command. The AD5767 contains an SDO pin to allow the user to daisy-chain multiple devices together or to read back the contents of the status register.

Readback Operation

The contents of the status registers can be read back via the SDO pin. Figure 4 shows how the registers are decoded. After a register has been addressed for a read, the next 24 clock cycles clock the data out on the SDO pin. The clocks must be applied while SYNC is low. For a read of a single register, the no operation (NOP) function clocks out the data. Alternatively, if more than one register is to be read, the data of the first register to be addressed clocks out at the same time that the second register to be read is being addressed.

Daisy-Chain Operation

Daisy chaining minimizes the number of port pins required from the controlling IC. As shown in Figure 44, the SDO pin of one package must be tied to the SDI pin of the next package. To enable daisy-chain mode, the DC_EN bit in Table 14 must be high. When two AD5767 devices are daisy-chained, 48 bits of data are required. The first 24 bits are assigned to U2, and the second 24 bits are assigned to U1, as shown in Figure 44. Keep the SYNC pin low until all 48 bits are clocked into their respective serial registers.

The SYNC pin is then pulled high to complete the operation.

To prevent data from mislocking (for example, due to noise) the device includes an internal counter; if the SCLK falling edges count is not a multiple of 24, the device ignores the command. A valid clock count is 24, 48, 72, and so on. The counter resets when SYNC returns high.

Daisy-chain mode is disabled by default and is enabled using the daisy-chain control register (see Table 14).

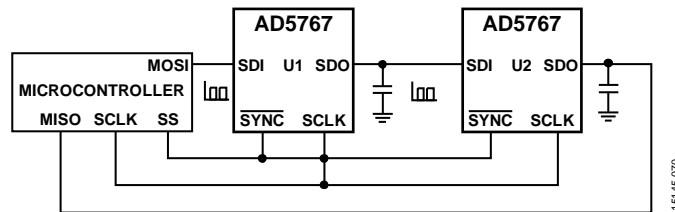


Figure 44. Daisy-Chain Block Diagram

REGISTER DETAILS

INPUT SHIFT REGISTER

The input shift register of the [AD5767](#) is 24 bits wide. Data is loaded MSB first (D23). The first four bits are the command bits, C3 to C0 (see Figure 45), followed by the 4-bit DAC address bits (see Table 10), and finally the data bits. The 24-bit data-word is transferred to the input register on the 24 falling edges of SCLK and are updated on the rising edge of SYNC.

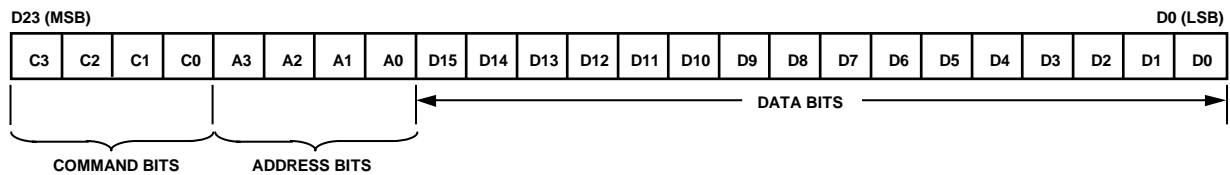


Figure 45. Input Shift Register Content

Table 9. Command Definitions¹

| C3 | C2 | C1 | C0 | A3 | A2 | A1 | A0 | Name | Description |
|----|----|----|----|-----------------|-----------------|-----------------|-----------------|--|---|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | NOP/monitor mux control | No operation (all zeros register). Monitor mux control register (D4 = 1) determines whether a DAC output or no output is switched out on the MUX_OUT pin. |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | Daisy-chain mode | Enables/disables the SDO output buffer for daisy-chain mode. |
| 0 | 0 | 0 | 1 | A3 ² | A2 ² | A1 ² | A0 ² | Write to DACx input register | Writes data to the input register for the selected DAC channel. |
| 0 | 0 | 1 | 0 | A3 ² | A2 ² | A1 ² | A0 ² | Write to input register and DAC register | Writes data to the input register and DAC register for the selected DAC channel. |
| 0 | 0 | 1 | 1 | X | X | X | X | Software load DAC (LDAC) | Updates the selected DAC register with data from the corresponding input register. |
| 0 | 1 | 0 | 0 | X | X | X | X | Span | Selects the output span of the AD5767 . |
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | Power control (DAC channel) | Powers up/down selected DAC outputs of individual DAC channels. |
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 1 | Power control (dither) | Powers up/down dither functionality of individual DAC channels. |
| 0 | 1 | 1 | 0 | X | X | X | X | Write input data to all DAC registers | Writes data to input registers and DAC registers for all DAC channels. |
| 0 | 1 | 1 | 1 | 0 | 0 | 0 | 0 | Software full reset | Writing 0x1234 to this register resets the AD5767 . |
| 1 | 0 | 0 | 0 | A3 ² | A2 ² | A1 ² | A0 ² | Select register for readback | Selects the register to read back for a selected DAC channel. |
| 1 | 0 | 0 | 1 | X | X | X | X | Apply N0 or N1 dither signal to DACs (DAC 7 to DAC 0) | Selects whether dither on N0, dither on N1, or no dither is applied to each DAC output. |
| 1 | 0 | 1 | 0 | X | X | X | X | Apply N0 or N1 dither signal to DACs (DAC 15 to DAC 8) | Selects whether dither on N0, dither on N1, or no dither is applied to each DAC output. |
| 1 | 1 | 0 | 0 | X | X | X | X | Dither scale (DAC 7 to DAC 0) | Scales the dither signal applied to the selected DAC outputs. |
| 1 | 1 | 0 | 1 | X | X | X | X | Dither scale (DAC 15 to DAC 8) | Scales the dither signal applied to the selected DAC outputs. |
| 1 | 0 | 1 | 1 | X | X | X | X | Invert dither | Inverts the dither signal applied to the selected DAC outputs. |
| 1 | 1 | 1 | 0 | X | X | X | X | Reserved | Not applicable. |
| 1 | 1 | 1 | 1 | X | X | X | X | Reserved | Not applicable. |

¹ X means don't care.

² See Table 10 for the address bit setting.

Table 10 shows the DAC x address commands. For applications using the WLCSP package that do not require all 16 channels, do not use Channel 8 because it is more sensitive to crosstalk and digital feedthrough.

Table 10. DAC x Address Commands

| Address | | | | Selected DAC |
|---------|----|----|----|--------------|
| A3 | A2 | A1 | A0 | |
| 0 | 0 | 0 | 0 | DAC 0 |
| 0 | 0 | 0 | 1 | DAC 1 |
| 0 | 0 | 1 | 0 | DAC 2 |
| 0 | 0 | 1 | 1 | DAC 3 |
| 0 | 1 | 0 | 0 | DAC 4 |
| 0 | 1 | 0 | 1 | DAC 5 |
| 0 | 1 | 1 | 0 | DAC 6 |
| 0 | 1 | 1 | 1 | DAC 7 |
| 1 | 0 | 0 | 0 | DAC 8 |
| 1 | 0 | 0 | 1 | DAC 9 |
| 1 | 0 | 1 | 0 | DAC 10 |
| 1 | 0 | 1 | 1 | DAC 11 |
| 1 | 1 | 0 | 0 | DAC 12 |
| 1 | 1 | 0 | 1 | DAC 13 |
| 1 | 1 | 1 | 0 | DAC 14 |
| 1 | 1 | 1 | 1 | DAC 15 |

MONITOR MUX CONTROL

The monitor mux control command determines whether one of the DAC outputs or none is switched out on the MUX_OUT pin depending on the desired D[4:0] value. To assert the no operation command, write all zeros to the D15 to D0 bits.

Table 11. Monitor Mux Control Register

| D23 | D22 | D21 | D20 | D19 | D18 | D17 | D16 | D15 to D5 | D4 to D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|------------|----------|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | Don't care | VOUT_SEL |

Table 12. Output Voltage Selection from Mux

| VOUT_SEL, Bits[4:0] ¹ | | | | | Mux Output |
|----------------------------------|---|---|---|---|---------------------------|
| 0 | X | X | X | X | No output is switched out |
| 1 | 0 | 0 | 0 | 0 | V _{OUT0} |
| 1 | 0 | 0 | 0 | 1 | V _{OUT1} |
| 1 | 0 | 0 | 1 | 0 | V _{OUT2} |
| 1 | 0 | 0 | 1 | 1 | V _{OUT3} |
| 1 | 0 | 1 | 0 | 0 | V _{OUT4} |
| 1 | 0 | 1 | 0 | 1 | V _{OUT5} |
| 1 | 0 | 1 | 1 | 0 | V _{OUT6} |
| 1 | 0 | 1 | 1 | 1 | V _{OUT7} |
| 1 | 1 | 0 | 0 | 0 | V _{OUT8} |
| 1 | 1 | 0 | 0 | 1 | V _{OUT9} |
| 1 | 1 | 0 | 1 | 0 | V _{OUT10} |
| 1 | 1 | 0 | 1 | 1 | V _{OUT11} |
| 1 | 1 | 1 | 0 | 0 | V _{OUT12} |
| 1 | 1 | 1 | 0 | 1 | V _{OUT13} |
| 1 | 1 | 1 | 1 | 0 | V _{OUT14} |
| 1 | 1 | 1 | 1 | 1 | V _{OUT15} |

¹ X means don't care.

NO OPERATION

Writing all zeros does not vary the state of the device.

Table 13. No Operation Register

| D23 | D22 | D21 | D20 | D19 | D18 | D17 | D16 | D15 to D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|---------------------|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0000 0000 0000 0000 |

DAISY-CHAIN MODE

To use the daisy-chain mode, enable the DC_EN bit in the daisy-chain control register. This bit is linked to the internal SDO buffer. If the functionality is not required, set the DC_EN bit to 0 to save the power consumed by the SDO buffer.

Table 14. Daisy-Chain Control Register

| D23 | D22 | D21 | D20 | D19 | D18 | D17 | D16 | D15 to D1 | D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|------------|-------|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | Don't care | DC_EN |

Table 15. Daisy-Chain Enable/Disable Bit description

| DC_EN | Description |
|-------|--------------------------------|
| 0 | Daisy chain disabled (default) |
| 1 | Daisy chain enabled |

WRITE AND UPDATE COMMANDS**Write to DAC x Input Register**

This command allows the user to write to the dedicated input register of each DAC individually. The output of the DAC does not change its value until a write to the software LDAC register occurs with the appropriate bit set to include the addressed channel in the update.

Table 16. Write to DAC x Input Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D4 | D3 to D0 |
|-----|-----|-----|-----|------------------------------|---------------------|-------------|
| 0 | 0 | 0 | 1 | DAC x address (see Table 10) | Input register data | Do not care |

Write to Input Register and DAC Register

This command writes directly to the selected DAC register and updates the output accordingly.

Table 17. Write to DACx Input and DAC Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D4 | D3 to D0 |
|-----|-----|-----|-----|------------------------------|---------------------|-------------|
| 0 | 0 | 1 | 0 | DAC x address (see Table 10) | Input register data | Do not care |

Software LDAC Register

This command copies data from the selected input registers to the corresponding DAC registers and the outputs update accordingly.

Table 18. Software LDAC Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D0 |
|-----|-----|-----|-----|-------------|-----------------------------|
| 0 | 0 | 1 | 1 | Do not care | LDAC (bit for each channel) |

Table 19. LDAC Bit Description

| LDAC | Description |
|------|-----------------------|
| 0 | Do not update channel |
| 1 | Update channel |

SPAN REGISTER

This register selects the output span of the AD5767. See Table 21 and Table 22. Always issue a software reset before writing to the span register.

Table 20. Span Register

| D23 | D22 | D21 | D20 | D19 to D5 | D4 to D3 | D2 to D0 |
|-----|-----|-----|-----|-------------|-----------------------------|---------------|
| 0 | 1 | 0 | 0 | Do not care | P[1:0] (power-up condition) | S[2:0] (span) |

Table 21. Span Selection

| S2 | S1 | S0 | Output Voltage Range |
|----|----|----|----------------------|
| 0 | 0 | 0 | −20 V to 0 V |
| 0 | 0 | 1 | −16 V to 0 V |
| 0 | 1 | 0 | −10 V to 0 V |
| 0 | 1 | 1 | −12 V to +14 V |
| 1 | 0 | 0 | −16 V to +10 V |
| 1 | 0 | 1 | −10 V to +6 V |
| 1 | 1 | 0 | −5 V to +5 V |
| 1 | 1 | 1 | −10 V to +10 V |

Table 22. Power-Up Condition Selection

| P1 | P0 | Power-Up Condition |
|----|------------|--------------------|
| 0 | 0 | Zero scale |
| 0 | 1 | Midscale |
| 1 | Don't care | Full scale |

POWER CONTROL REGISTER

The power control register powers up or powers down individual DACs and their associated amplifiers. It is recommended to power down any unused channels during the first write to the AD5767.

The power control register with D[19:16] = 0001 powers up or powers down the dither functionality of the individual DACs.

Table 23. Power Control Register (DAC Control)

| D23 | D22 | D21 | D20 | D19 | D18 | D17 | D16 | D15 to D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|--|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | Power-down bit for each channel output (for example, D15 = DAC 15, D8 = DAC 8, and D0 = DAC 0) |

Table 24. Power Control Register (Dither)

| D23 | D22 | D21 | D20 | D19 | D18 | D17 | D16 | D15 to D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|--|
| 0 | 1 | 0 | 1 | 0 | 0 | 0 | 1 | Power-down bit for each channel dither block (for example, D15 = DAC 15, D8 = DAC 8, and D0 = DAC 0) |

Table 25. Power Control

| D16 | Operating Mode |
|-----|----------------------------|
| 0 | Normal operation (default) |
| 1 | Powered down |

WRITE INPUT DATA TO ALL DAC REGISTERS

This command writes the data in D[15:0] to the DAC register of all DACs and sets all DAC outputs to the same value. For the AD5767 12-bit resolution DAC, the data is written in D[15:4].

Table 26. Write Input Data to All DAC Registers

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D4 | D3 to D0 |
|-----|-----|-----|-----|------------|-------------------|-------------|
| 0 | 1 | 1 | 0 | Don't care | DAC register data | Do not care |

SOFTWARE FULL RESET

Writing 0x1234 initiates a reset routine, which returns the AD5767 to its power-on state.

Table 27. Software Full Reset Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D12 | D11 to D8 | D7 to D4 | D3 to D0 |
|-----|-----|-----|-----|------------|------------|-----------|----------|----------|
| 0 | 1 | 1 | 1 | 0000 | 0001 | 0010 | 0011 | 0100 |

SELECT REGISTER FOR READBACK

This command selects which registers to read back (see Table 28). After issuing this command, the contents of the selected registers are clocked out on the SDO on the next 24-bit frame (see Table 29).

Table 28. Initiate Readback Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D0 |
|-----|-----|-----|-----|------------------------------|-------------|
| 1 | 0 | 0 | 0 | DAC x address (see Table 10) | Do not care |

Table 29. Readback Data Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D10 | D9 | D8 to D7 | D6 to D5 | D4 | D3 | D2 to D0 |
|-----|-----|-----|-----|------------------------------|------------|---------------|--------------|---------------|------------|----------|-------------|
| 1 | 0 | 0 | 0 | DAC x address (see Table 10) | 000000 | Invert dither | Dither scale | Dither signal | Power down | Reserved | Span S[2:0] |

Table 30. Readback Register Data Functions

| Bit Name | Description | | | |
|---------------|---|---|-----------------------|-----------------------------|
| Span S[2:0] | Span register | | | |
| | D2 | D1 | D0 | Output Voltage Range |
| | 0 | 0 | 0 | -20 V to 0 V |
| | 0 | 0 | 1 | -16 V to 0 V |
| | 0 | 1 | 0 | -10 V to 0 V |
| | 0 | 1 | 1 | -12 V to +14 V |
| | 1 | 0 | 0 | -16 V to +10 V |
| | 1 | 0 | 1 | -10 V to +6 V |
| | 1 | 1 | 0 | -5 V to +5 V |
| 1 | 1 | 1 | -10 V to +10 V | |
| Reserved | D3 | This is a reserved bit; ignore its contents | | |
| Power Down | Power-down register | | | |
| | D4 | Operating Mode | | |
| | 0 | Channel normal operation | | |
| 1 | Channel not powered down | | | |
| Dither Signal | Apply N0 or N1 dither signal to DACs register | | | |
| | D6 | D5 | Dither Setting | |
| | 0 | 0 | No dither applied | |
| | 0 | 1 | N0 dither applied | |
| | 1 | 0 | N1 dither applied | |
| 1 | 1 | No dither applied | | |

| Bit Name | Description | | |
|---------------|------------------------|-------------------------------|----------------|
| Dither Scale | Dither scale register | | |
| | D8 | D7 | Scaling Factor |
| | 0 | 0 | No scaling |
| | 0 | 1 | 75% scaling |
| | 1 | 0 | 50% scaling |
| 1 | 1 | 25% scaling | |
| Invert Dither | Invert dither register | | |
| | D9 | Dither Mode | |
| | 0 | Dither signal is not inverted | |
| | 1 | Dither signal is inverted | |

APPLY N0 OR N1 DITHER SIGNAL TO DACs REGISTER

These commands determine which dither signal, N0 or N1, is applied to the selected DACs. Couple the dither signals to the [AD5767](#) outputs after the dither signals are configured and the clamp to ground is removed by writing to the span register. Refer to the Applications Information section for a more information.

Table 31. Apply N0 or N1 Dither Signal to DACs Register (DAC 7 to DAC 0)

| D23 to D20 | D19 to D16 | D15 to D14 | D13 to D12 | D11 to D10 | D9 to D8 | D7 to D6 | D5 to D4 | D3 to D2 | D1 to D0 |
|------------|-------------|------------|------------|------------|----------|----------|----------|----------|----------|
| 1001 | Do not care | DAC 7 | DAC 6 | DAC 5 | DAC 4 | DAC 3 | DAC 2 | DAC 1 | DAC 0 |

Table 32. Apply N0 or N1 Dither Signal to DACs Register (DAC 15 to DAC 8)

| D23 to D20 | D19 to D16 | D15 to D14 | D13 to D12 | D11 to D10 | D9 to D8 | D7 to D6 | D5 to D4 | D3 to D2 | D1 to D0 |
|------------|-------------|------------|------------|------------|----------|----------|----------|----------|----------|
| 1010 | Do not care | DAC 15 | DAC 14 | DAC 13 | DAC 12 | DAC 11 | DAC 10 | DAC 9 | DAC 8 |

Table 33 shows the dither scaling setting using Bits[D15:D14] as an example. To apply the N0 dither to DAC 7 (see Table 31), set D15 to 0 and D14 to 1. The same dither selection settings apply to the other bits, Bits[D13:D12], Bits[D11:D10], Bits[D9:D8], Bits[D7:D6], Bits[D5:D4], Bits[D3:D2], and Bits[D1:D0] in Table 31 and Table 32.

Table 33. Dither Selection for DAC x (DAC 0 to DAC 15)

| D15 | D14 | Dither Setting |
|-----|-----|--------------------------|
| 0 | 0 | No dither applied |
| 0 | 1 | N0 dither signal applied |
| 1 | 0 | N1 dither signal applied |
| 1 | 1 | No dither applied |

DITHER SCALE

This command scales the dither before it is applied to the selected channel.

Table 34. Dither Scaling Register (DAC 7 to DAC 0)

| D23 to D20 | D19 to D16 | D15 to D14 | D13 to D12 | D11 to D10 | D9 to D8 | D7 to D6 | D5 to D4 | D3 to D2 | D1 to D0 |
|------------|-------------|------------|------------|------------|----------|----------|----------|----------|----------|
| 1100 | Do not care | DAC 7 | DAC 6 | DAC 5 | DAC 4 | DAC 3 | DAC 2 | DAC 1 | DAC 0 |

Table 35. Dither Scaling Register (DAC 15 to DAC 8)

| D23 to D20 | D19 to D16 | D15 to D14 | D13 to D12 | D11 to D10 | D9 to D8 | D7 to D6 | D5 to D4 | D3 to D2 | D1 to D0 |
|------------|-------------|------------|------------|------------|----------|----------|----------|----------|----------|
| 1101 | Do not care | DAC 15 | DAC 14 | DAC 13 | DAC 12 | DAC 11 | DAC 10 | DAC 9 | DAC 8 |

Table 36 shows the dither scaling setting using Bits[D15:D14] as an example. To apply 25% scaling to DAC 7 (see Table 34), set D15 to 1 and D14 to 1. The same dither scaling settings apply to the other bits, Bits[D13:D12], Bits[D11:D10], Bits[D9:D8], Bits[D7:D6], Bits[D5:D4], Bits[D3:D2], and Bits[D1:D0] in Table 31 and Table 32.

Table 36. Apply Dither Signal to DAC x (DAC 0 to DAC 15)

| D15 | D14 | Scaling Factor |
|-----|-----|----------------|
| 0 | 0 | No scaling |
| 0 | 1 | 75% scaling |
| 1 | 0 | 50% scaling |
| 1 | 1 | 25% scaling |

INVERT DITHER REGISTER

This command inverts the dither applied to the selected DACs when the appropriate bit is set to 0.

Table 37. Invert Dither Register

| D23 | D22 | D21 | D20 | D19 to D16 | D15 to D0 |
|-----|-----|-----|-----|-------------|---|
| 1 | 0 | 1 | 1 | Do not care | Dx (invert dither bit for each channel) |

Table 38. Invert Dither

| Dx | Dither Mode |
|----|---|
| 0 | Dither signal is not inverted (default) |
| 1 | Dither signal is inverted |

APPLICATIONS INFORMATION

DITHER CONFIGURATION

The AD5767 contains two dither input pins to allow dither tone signals to be coupled to any of the 16 DAC output channels.

Operate the AD5767 using the dither functionality to minimize the transient amplitude seen on the DAC outputs when the dither functionality is enabled or disabled. The recommended configuration of the dither functionality is as follows:

1. After the AD5767 powers up, the input dither signals must be configured by writing to the dither scale register and the invert dither register.
2. Configure the AD5767 in normal operating mode before applying dither by programming the span register, allowing the output clamp on the AD5767 to be removed.
3. Write to the apply N0 or N1 dither signal to DACs register to couple the N0/N1 input dither signals to any DAC output, V_{OUTX} .

Enabling the dither feature on a channel can increase its sensitivity to digital feedthrough.

THERMAL CONSIDERATIONS

Up to ± 20 mA can be sourced from each channel on the AD5767; thus, it is important to understand the effects of power dissipation on the package and its effects on junction temperature. The internal junction temperature must not exceed 150°C . The AD5767 is packaged in a 49-ball, $4\text{ mm} \times 4\text{ mm}$ WLCSP and a 40-lead $6\text{ mm} \times 6\text{ mm}$ LFCSP package. The thermal impedance, θ_{JA} , is specified in the Absolute Maximum Ratings section. It is important that the device is not operated under conditions that cause the junction temperature to exceed the maximum temperature specified in the Absolute Maximum Ratings section.

The Thermal Calculation Example (WLCSP) section details how to calculate the die temperature and maximum permitted ambient temperature. The quiescent current of the AV_{DD} , AV_{SS} , AV_{CC} , and V_{LOGIC} pins must also be included in the calculation of the junction temperature. These calculations use the typical supply currents specified in Table 1.

Thermal Calculation Example (WLCSP)

For this thermal calculation example, all 16 channels are enabled with the ± 10 V output voltage range used. Each channel is drawing 2 mA for a +1 V output voltage.

$$AV_{DD} = \text{Span} + 2\text{ V} = 12\text{ V}$$

$$AV_{SS} = \text{Span} - 2\text{ V} = -12\text{ V}$$

$$AV_{CC} = V_{LOGIC} = 3.3\text{ V}$$

where Span is the output voltage range, ± 10 V.

The current required to supply 16 channels (output power) is

$$2\text{ mA} \times 16 = 32\text{ mA}$$

The power required on the AV_{DD} rail for the AD5767 to supply the 16 channels and 6 mA typical supply current is

$$12\text{ V} \times (32\text{ mA} + 6\text{ mA}) = 0.456\text{ W}$$

Next, add power dissipated by the AV_{SS} , AV_{CC} , and V_{LOGIC} rails (input power) as follows:

$$0.456\text{ W} + (-12\text{ V} \times -9\text{ mA}) + (3.3\text{ V} \times 8.3\text{ mA}) + (3.3\text{ V} \times 0.02\text{ }\mu\text{A}) = 0.59\text{ W}$$

To calculate the power dissipated by the AD5767, use the following equation:

$$P_{DISS} = \text{Input Power} - \text{Output Power}$$

For example,

$$0.59\text{ W} - (32\text{ mA} \times 1\text{ V}) = 0.558\text{ W}$$

Then, calculate the die temperature,

$$0.558\text{ W} \times 53^{\circ}\text{C}/\text{W} = 29.57^{\circ}\text{C}$$

Using the following equation to calculate the maximum permitted ambient temperature:

$$T_{A\text{ MAX}} = T_{J\text{ MAX}} - \text{Die Temperature}$$

For example,

$$150^{\circ}\text{C} - 29.57^{\circ} = 120^{\circ}\text{C}$$

The θ_{JA} specification assumes that proper layout and grounding techniques are followed to minimize power dissipation, as outlined in the Layout Guidelines section

MICROPROCESSOR INTERFACING

Microprocessor interfacing to the AD5767 is via a serial bus that uses a standard protocol compatible with DSPs and microcontrollers. The communications channel requires a 4-wire serial interface consisting of a clock signal, a data input signal, a data output signal, and a synchronization signal. The device requires a 24-bit data-word with data valid on the falling edge of SCLK.

AD5767 TO SPI INTERFACE

The SPI interface of the AD5767 is designed to be easily connected to industry-standard DSPs and microcontrollers. Figure 46 shows the AD5767 connected to the Analog Devices, Inc., ADSP-BF531 Blackfin® DSP. The Blackfin has an integrated SPI port that can be connected directly to the SPI pins of the AD5767.

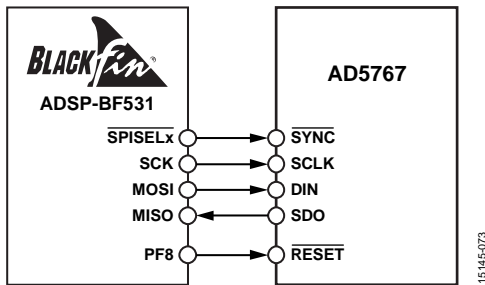


Figure 46. ADSP-BF531 SPI Interface

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LAYOUT GUIDELINES

In any circuit where accuracy is important, careful consideration of the power supply and ground return layout helps to ensure the rated performance. The PCB on which the AD5767 is mounted must be designed so that the AD5767 lies on the analog plane. Ensure that the board has separate analog and digital sections. If the AD5767 is in a system where other devices require an AGND to DGND connection, make the connection at one point only. Keep this ground point as close as possible to the AD5767.

The AD5767 must have ample supply bypassing of 10 μF in parallel with 0.1 μF on each supply, located as close to the package as possible, ideally right up against the device. The 10 μF capacitors are the tantalum bead type. The 0.1 μF capacitor must have low effective series resistance (ESR) and low effective series inductance (ESI). Ceramic capacitors, for example, provide a low impedance path to ground at high frequencies to handle transient currents due to internal logic switching.

Ensure that the power supply line has as large a trace as possible to provide a low impedance path and reduce glitch effects on

the supply line. Shield clocks and other fast switching digital signals from other parts of the board by using a digital ground. Avoid crossover of digital and analog signals if possible. When traces cross on opposite sides of the board, ensure that they run at right angles to each other to reduce feedthrough effects through the board. The best board layout technique is the microstrip technique, where the component side of the board is dedicated to the ground plane only, and the signal traces are placed on the solder side. However, this technique is not always possible with a 2-layer board.

It is often useful to provide some heat sinking capability to allow the power to dissipate easily.

For the WLCSP package, heat is transferred through the solder balls to the PCB board. θ_{JA} thermal impedance is dependent on board construction. More copper layers enable heat to be removed more effectively.

The LFCSP package of the AD5767 has an exposed pad beneath the device. Connect this pad to the AV_{SS} supply of the device. For optimum performance, use special consideration when designing the motherboard and mounting the package. For enhanced thermal, electrical, and board level performance, solder the exposed pad on the bottom of the package to the corresponding thermal land pad on the PCB. Design thermal vias into the PCB land pad area to improve heat dissipation further.

The AV_{SS} plane on the device can be increased (as shown in Figure 47) to provide a natural heat sinking effect.

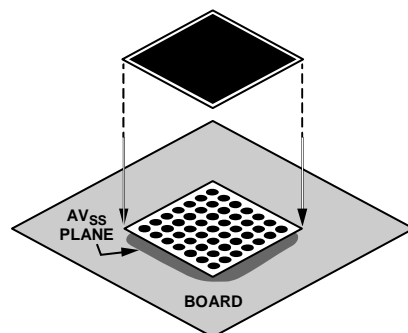


Figure 47. Exposed Pad Connection to Board

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OUTLINE DIMENSIONS

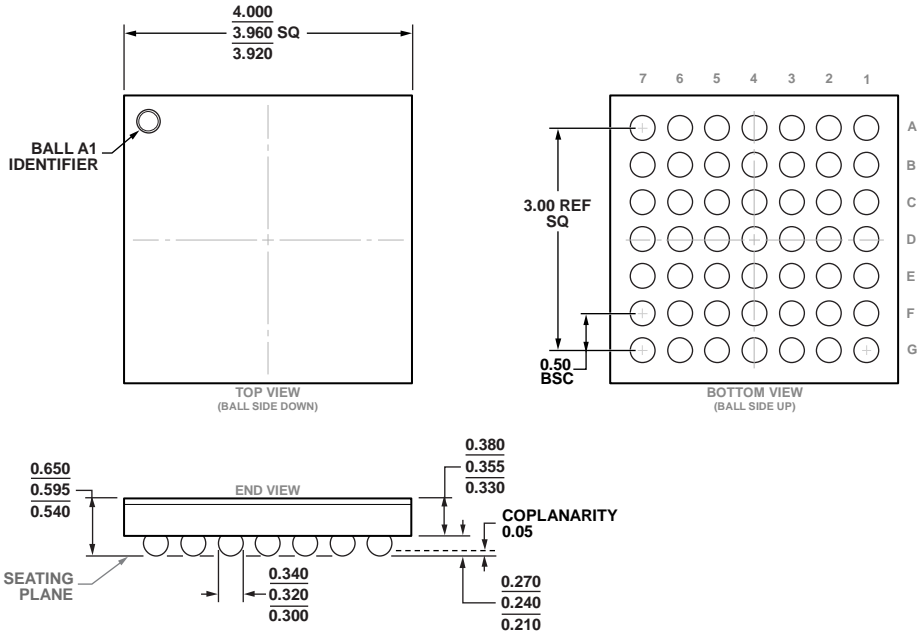
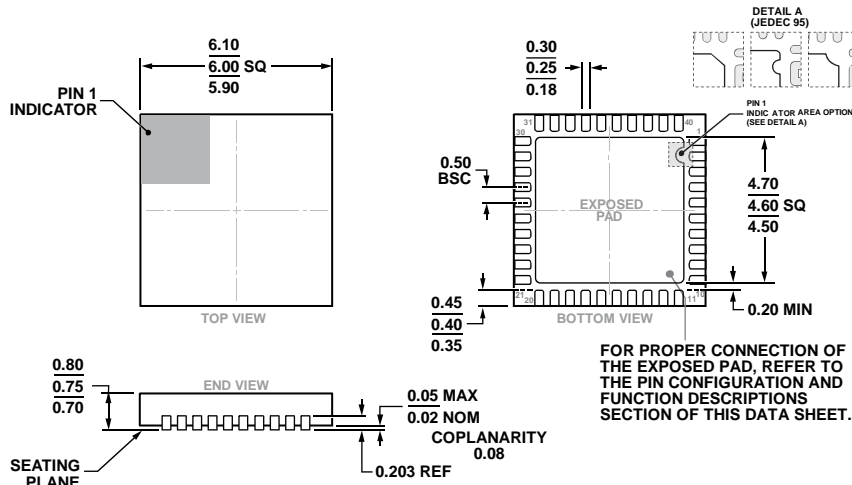


Figure 48. 49-Ball Wafer Level Chip Scale Package [WLCSP] (CB-49-4)
Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-220-WJJD-5
Figure 49. 40-Lead Lead Frame Chip Scale Package [LFCSP] (CP-40-7)
Dimensions shown in millimeters

ORDERING GUIDE

| Model ¹ | Resolution (Bits) | Temperature Range | Package Description | Package Option |
|--------------------|-------------------|-------------------|--|----------------|
| AD5767BCBZ-RL7 | 12 | −40°C to +105°C | 49-Ball Wafer Level Chip Scale Package [WLCSP] | CB-49-4 |
| AD5767BCPZ-RL7 | 12 | −40°C to +105°C | 40-Lead Lead Frame Chip Scale Package [LFCSP] | CP-40-7 |
| EVAL-AD5767SD2Z | | | Evaluation Board | |

¹ Z = RoHS Compliant Part.

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